

**BQ25125** 

SLUSDL9A - JUNE 2019 - REVISED JANUARY 2021

# BQ25125 Low Io Highly Integrated Battery Charge Management Solution For Wearables and IoT

#### 1 Features

- Increases system operation time between charges
  - Configurable 300-mA buck regulator (1.8 V default)
  - 700-nA (typical) Iq with buck converter enabled (No Load)
  - Configurable load switch or 100-mA LDO output (1.8 V default)
  - Up to 300-mA charge current for fast charging
  - 0.5% Accurate battery voltage regulation (configurable from 3.6 V to 4.65 V in 10-mV
  - Configurable termination current down to 500 uA
  - Simple voltage based battery monitor
  - Watchdog timer enabled by default
  - VDPPM Loop disabled
  - VINDPM Disabled by default to support low voltage charging
- Highly integrated solution with small footprint
  - 2.5 mm x 2.5 mm WCSP Package and 6 external components for minimal solution
  - Push-button wake-up and reset with adjustable
  - Power path management for powering the system and charging the battery
  - Power path management enables <50 nA ship mode battery quiescent current for longest shelf
  - Battery charger operates from 3.4 V 5.5 V<sub>IN</sub> (5.5-V OVP / 20-V tolerant)
  - Dedicated pins for input current limit, charge current, termination current, and status output
- I<sup>2</sup>C Communication control
  - Charge voltage and current
  - Termination threshold
  - Input current limit
  - VINDPM Threshold
  - Timer options
  - Load switch control
  - Controls for interrupts for faults and status
  - System output voltage adjustment
  - LDO Output voltage adjustment
- Safety-Related Certification:
  - TUV IEC 62368-1 Certification

#### 2 Applications

- Smart watches and other wearable devices
- Fitness accessories

- Health monitoring medical accessories
- Rechargeable toys
- True wireless headsets (TWS)
- Wirelessly charged products

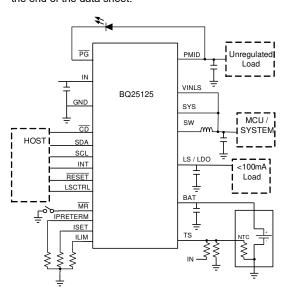
## 3 Description

The BQ25125 is a highly integrated battery charge management IC that integrates the most common functions for wearable devices: Linear charger, regulated output, load switch, manual reset with timer, and battery voltage monitor. The integrated buck converter is a high efficiency, low IQ switcher using DCS-Control™ that extends light load efficiency down to 10-uA load currents.

#### **Device Information**

PART NUMBER		PACKAGE <sup>(1)</sup>	BODY SIZE (NOM)		
	BQ25125	DSBGA (25)	2.50 mm x 2.50 mm		

For all available packages, see the orderable addendum at the end of the data sheet.



Simplified Schematic



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# **4 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

C	hanges from Revision * (June 2019) to Revision A (January 2021)	Page
•	Added Safety-Related Certification to Features	
•	Added Device Comparison table	<mark>3</mark>
	Changed Storage Temperature	
	Changed R <sub>DS(ON LDO)</sub>	
	Changed Figure 8-2	
•	Deleted Update STAT to fault in VIN_UV actions in Fault and Status Condition Responses	31
•	Changed VIN_UV description	37
•	Deleted I <sup>2</sup> C Address from title	40

## **5 Description (continued)**

The low quiescent current during operation and shutdown enables maximum battery life. The device supports charge currents from 5 mA to 300 mA. The input current limit, charge current, buck converter output voltage, LDO output voltage, and other parameters are programmable through the I<sup>2</sup>C interface.

The battery is charged using a standard Li-Ion charge profile with three phases: precharge, constant current and constant voltage. A voltage-based JEITA compatible battery pack thermistor monitoring input (TS) is included that monitors battery temperature and automatically changes charge parameters to prevent the battery from charging outside of its safe temperature range. The charger is optimized for 5-V USB input, with 20-V tolerance to withstand line transients. The buck converter is run from the input or battery. When in battery only mode, the device can run from a battery up to 4.65 V.

A configurable load switch allows system optimization by disconnecting infrequently used devices. The manual reset with timer allows multiple different configuration options for wake are reset optimization. A simple voltage based monitor provides battery level information to the host in 2% increments from 60% to 100% of the programmed  $V_{(BATREG)}$ .

## **6 Device Comparison Table**

PART NUMBER	DEFAULT VINDPM	DEFAULT SYS OUTPUT	DEFAULT LDO OUTPUT	DEFAULT VBATREG	DEFAULT CHARGE CURRENT	DEFAULT TERMINATION CURRENT	VDPPM	WATCHDOG
BQ25120A	Enabled	1.8 V	Load Switch	4.2 V	10 mA	2 mA	Enabled	Enabled
BQ25121A	Enabled	2.5 V	Load Switch	4.2 V	10 mA	2 mA	Enabled	Disabled
BQ25122	Enabled	1.2 V	Load Switch	4.2 V	11 mA	0.5 mA	Enabled	Enabled
BQ25125	Disabled	1.8 V	1.8 V (LDO)	4.2 V	10 mA	2 mA	Disabled	Enabled

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# 7 Pin Configuration and Functions

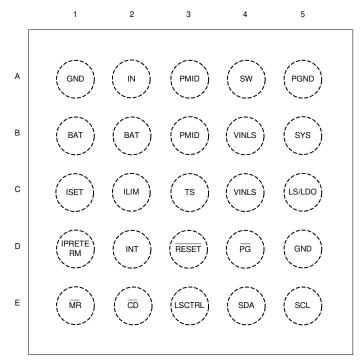


Figure 7-1. YFP Package 25-Pin DSBGA Top View

**Table 7-1. Pin Functions** 

F	PIN	I/O	DESCRIPTION				
NAME			DESCRIPTION				
IN	A2	I	DC Input Power Supply. IN is connected to the external DC supply. Bypass IN to GND with at least 1 µF of capacitance using a ceramic capacitor.				
PMID	A3, B3	1/0	High Side Bypass Connection. Connect at least $3\mu F$ of ceramic capacitance with DC bias derating from PMID to GND as close to the PMID and GND pins as possible. When entering Ship Mode, PMID is discharged by a $20\text{-}k\Omega$ internal discharge resistor.				
GND	A1, D5		Ground connection. Connect to the ground plane of the circuit.				
PGND	A5		Power ground connection. Connect to the ground plane of the circuit. Connect the output filter cap from the buck converter to this ground as shown in the layout example.				
CD	E2	I	Chip Disable. Drive $\overline{CD}$ low to place the part in High-Z mode with battery only present, or enable charging when $V_{\text{IN}}$ is valid. Drive $\overline{CD}$ high for Active Battery mode when battery only is present, and disable charge when $V_{\text{IN}}$ is present. $\overline{CD}$ is pulled low internally with 900 k $\Omega$ .				
SDA	E4	I/O	l <sup>2</sup> C Interface Data. Connect SDA to the logic rail through a 10-kΩ resistor.				
SCL	E5	I	l <sup>2</sup> C Interface Clock. Connect SCL to the logic rail through a 10-kΩ resistor.				
ILIM	C2	I	Adjustable Input Current Limit Programming. Connect a resistor from ILIM to GND to program the input current limit. The input current includes the system load and the battery charge current. Connect ILIM to GND to set the input current limit to the internal default threshold. ILIM can also be updated through I <sup>2</sup> C.				
LSCTRL	E3	I	Load Switch and LDO Control Input. Pull high to enable the LS/LDO output, pull low to disable the LS/LDO output.				
ISET	C1	I	Fast-Charge Current Programming Input. Connect a resistor from ISET to GND to program the fast-charge current level. Connect a resistor from ISET to GND to set the charge current to the internal default. ISET can also be updated through I <sup>2</sup> C. While charging, the voltage at ISET reflects the actual charging current and can be used to monitor charge current if an ISET resistor is present and the device is not in host mode.				

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## **Table 7-1. Pin Functions (continued)**

P	IN	l vo	PERCENTION			
NAME	NO.	I/O	DESCRIPTION			
IPRETERM	D1	I	Termination current programming input. Connect a $0-\Omega$ to $10-k\Omega$ resistor from IPRETERM to GND to program the termination current between 5% and 20% of the charge current. The pre-charge current is the same as the termination current setting. Connect IPRETERM to GND to set the termination current to the internal default threshold. IPRETERM can also be updated through I <sup>2</sup> C.			
INT	D2	0	Status Output. INT is an open-drain output that signals charging status and fault interrupts. INT pulls low during charging. INT is high impedance when charging is complete, disabled, or the charger is in high impedance mode. When a fault occurs, a 128 $\mu$ s pulse is sent out as an interrupt for the host. INT charge indicator function is enabled/disabled using the EN_INT bit in the control register. Connect INT to a logic rail using an LED for visual indication of charge status or through a 100 $\mu$ C resistor to communicate with the host processor.			
PG	D4	0	Open-drain Power Good status indication output. $\overline{PG}$ pulls to GND when $V_{IN}$ is above $V_{(BAT)}+V_{SLP}$ and less that $V_{OVP}$ . $\overline{PG}$ is high-impedance when the input power is not within specified limits. Connect $\overline{PG}$ to the desired logic voltage rail using a $1k\Omega$ to $100k\Omega$ resistor, or use with an LED for visual indication. $\overline{PG}$ can also be configured as a push-button voltage shifted output (MRS) in the registers, where the output of the $\overline{PG}$ pin reflects the status of the $\overline{MR}$ input, but pulled up to the desired logic voltage rail using a $1k\Omega$ to $100k\Omega$ resistor.			
RESET	D3	0	Reset Output. $\overline{RESET}$ is an open drain active low output that goes low when $\overline{MR}$ is held low for longer than $t_{RESET}$ , which is configurable by the MRRESET registers. $\overline{RESET}$ is deasserted after the $t_{RESET\_D}$ , typically 400ms.			
MR	E1	I	Manual Reset Input. $\overline{MR}$ is a push-button input that must be held low for greater than $t_{RESET}$ to assert the reset output. If $\overline{MR}$ is pressed for a shorter period, there are two programmable timer events, $t_{WAKE1}$ and $t_{WAKE2}$ , that trigger an interrupt to the host. The $\overline{MR}$ input can also be used to bring the device out of Ship mode.			
SW	A4	0	Inductor Connection. Connect to the switched side of the external inductor.			
SYS	B5	I	System Voltage Sense Connection. Connect SYS to the system output at the output bulk capacitors. Bypass SYS locally with at least 4.7 µF of effective ceramic capacitance.			
LS/LDO	C5	0	Load Switch or LDO output. Connect 1 $\mu$ F of effective ceramic capacitance to this pin to assure stability. Be sure to account for capacitance bias voltage derating when selecting the capacitor.			
VINLS	B4, C4	I	Input to the Load Switch / LDO output. Connect 1 $\mu F$ of effective ceramic capacitance from this pin to GND.			
BAT	B1, B2	I/O	Battery Connection. Connect to the positive terminal of the battery. Bypass BAT to GND with at least 1 $\mu$ F of ceramic capacitance.			
TS	C3	I	Battery Pack NTC Monitor. Connect TS to the center tap of a resistor divider from VIN to GND. The NTC is connected from TS to GND. The TS function provides four thresholds for JEITA compatibility. TS faults are reported by the I <sup>2</sup> C interface during charge mode.			



## **8 Specifications**

## 8.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

			MIN	MAX	UNIT
	IN	wrt GND	-0.3	20	V
Input voltage	PMID, VINLS	wrt GND	-0.3	7.7	V
mpat voltage	CD, SDA, SCL, ILIM, ISET, IPRETERM, LSCTRL, INT, RESET, TS	wrt GND	-0.3	5.5	V
Output voltage	SYS			3.6	V
Input current	IN			400	mA
Sink current	INT			10	mA
Sink/Source Current	RESET			10	mA
Output Voltage Continuos	SW		-0.7	7.7	V
Output Current Centinuous	SW			400	mA
Output Current Continuous	SYS, BAT			300	mA
Current	LS/LDO			150	mA
BAT Operating Voltage	VBAT, MR,			6.6	V
Junction Temperature			-40	125	°C
Storage Temperature, T <sub>stg</sub>			-55	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 8.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±500	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

## 8.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V	IN voltage range	3.4	5	20	V
V <sub>IN</sub>	IN operating voltage range, recommended	3.4	5	5.5	V
V <sub>(BAT)</sub>	V <sub>(BAT)</sub> operating voltage range			5.5 <sup>(1)</sup>	V
V <sub>(VINLS)</sub>	VINLS voltage range for Load Switch	0.8		5.5 <sup>(2)</sup>	V
V <sub>(VINLS)</sub>	VINLS voltage range for LDO	2.2		5.5	V
I <sub>IN</sub>	Input Current, IN input			400	mA
I <sub>(SW)</sub>	Output Current from SW, DC			300	mA
I <sub>(PMID)</sub>	Output Current from PMID, DC			300	mA
ILS/LDO	Output Current from LS/LDO			100	mA
I <sub>(BAT)</sub> , I <sub>(SYS)</sub>	Charging and discharging using internal battery FET			300	mA
TJ	Operating junction temperature range	-40		125	°C

(1) Any voltage greater than shown should be a transient event.

(2) These inputs will support 6.6 V for less than 10% of the lifetime at V<sub>(BAT)</sub> or VIN, with a reduced current and/or performance.



## 8.4 Thermal Information

		BQ25125	
	THERMAL METRIC <sup>(1)</sup> 25 PINS  Junction-to-ambient thermal resistance 60 Junction-to-case (top) thermal resistance 0.3 Junction-to-board thermal resistance 12.0 Junction-to-top characterization parameter 1.2 Junction-to-board characterization parameter 12.0	UNIT	
		25 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	60	°C/W
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	0.3	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	12.0	°C/W
ΨЈТ	Junction-to-top characterization parameter	1.2	°C/W
ΨЈВ	Junction-to-board characterization parameter	12.0	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



### 8.5 Electrical Characteristics

Circuit of Figure 8-1,  $V_{(UVLO)} < V_{IN} < V_{(OVP)}$  and  $V_{IN} > V_{(BAT)} + V_{(SLP)}$ ,  $T_J = -40^{\circ}C$  to 85°C and  $T_J = 25^{\circ}C$  for typical values (unless otherwise noted)

	ARAMETERS	TEST CONDITIONS	MIN	TYP	MAX	UNIT
INPUT CURRE	NTS					
		$V_{(UVLO)}$ < $V_{IN}$ < $V_{(OVP)}$ and $V_{IN}$ > $V_{(BAT)}$ + $V_{(SLP)}$ PWM Switching, -40°C < $T_J$ < 85°C		1		mA
lin	Supply Current for Control	$V_{(UVLO)} < V_{IN} < V_{(OVP)}$ and $V_{IN} > V_{(BAT)} + V_{(SLP)}$ PWM NOT Switching			3	mA
		0°C < T <sub>J</sub> < 85°C, V <sub>IN</sub> = 5 V, Charge Disabled			1.5	mA
		$0^{\circ}\text{C} < \text{T}_{\text{J}} < 60^{\circ}\text{C}, \text{ V}_{\text{IN}} = 0 \text{ V, High-Z Mode, PWM Not}$ Switching, $\text{V}_{(\text{BUVLO})} < \text{V}_{(\text{BAT})} < 4.65 \text{ V}$	+ V <sub>(SLP)</sub> PWM 1  + V <sub>(SLP)</sub> PWM NOT 3  sabled 1.5  de, PWM Not 0.7 1.2  de, PWM Not 0.9 1.5  High-Z Mode, PWM 0.75 3.5  de, PWM Switching, 1.35 4.25  ery Mode, PWM ed, V <sub>(BUVLO)</sub> < V <sub>(BAT)</sub> < 6.8 12  active Battery Mode, Enabled, CD = Low, 6.2 11  2 150  125 170  120 160  V <sub>(PMID)</sub> < V <sub>(BAT)</sub> - 25  mV  V <sub>(PMID)</sub> < V <sub>(BAT)</sub> - 25  mV  V <sub>(PMID)</sub> < V <sub>(BAT)</sub> - 25  mV  1.35 1.35  50 400  K <sub>(ILIM)</sub> / R <sub>(I</sub>	μA		
BAT_ACTIVE)  BAT_SHIP)  OWER-PATH   DO(IN-PMID)  DO(BAT-PMID)  (BSUP1)  (BSUP2)  BAT_OCP)  LIM)	Battery discharge current	$0^{\circ}\text{C} < \text{T}_{\text{J}} < 60^{\circ}\text{C}, \text{ V}_{\text{IN}} = 0 \text{ V}, \text{ High-Z Mode, PWM Not Switching, V}_{(\text{BUVLO})} < \text{V}_{(\text{BAT})} < 6.6 \text{ V}$		0.9	1.5	μΑ
'(BAT_HIZ)	in High Impedance Mode	$0^{\circ}\text{C} < \text{T}_{\text{J}} < 60^{\circ}\text{C}, \text{ V}_{\text{IN}} = 0 \text{ V or floating, High-Z Mode, PWM}$ Switching, No Load		0.75	3.5	μΑ
		$0^{\circ}\text{C} < \text{T}_{\text{J}} < 85^{\circ}\text{C}$ , $\text{V}_{\text{IN}}$ = 0 V, High-Z Mode, PWM Switching, LSLDO enabled		1.35	1 3 1.5 0.7 1.2 0.9 1.5 0.75 3.5 1.35 4.25 6.8 12 6.2 11 2 150 125 170 120 160 (PMID) < ANT - 25 MV 1.15 1.35 400  K(ILIM) / R(ILIM) 12% 5% 200 225 200 210 4.9 3% 300 400 4.65	μΑ
l	Battery discharge current	$0^{\circ}\text{C} < \text{T}_{\text{J}} < 85^{\circ}\text{C},  \text{V}_{\text{IN}} = 0  \text{V},  \text{Active Battery Mode, PWM}$ Switching, LSLDO enabled, I2C Enabled, $ \text{V}_{(\text{BUVLO})} < \text{V}_{(\text{BAT})} < 4.65  \text{V}$		6.8	12	μΑ
(BAI_ACTIVE)	in Active Battery Mode	$\begin{array}{l} 0^{\circ}C < T_{J} < 85^{\circ}C, \ 0 < V_{IN} < V_{IN(UVLO)}, \ Active \ Battery \ Mode, \\ PWM \ Switching, \ LSLDO \ disabled, \ I2C \ Enabled, \ \overline{CD} = Low, \\ V_{(BUVLO)} < V_{(BAT)} < 4.65 \ V \end{array}$		6.2	11	μΑ
I <sub>(BAT_SHIP)</sub>	Battery discharge current in Ship Mode	0°C < T <sub>J</sub> < 85°C, V <sub>IN</sub> = 0 V, Ship Mode		2	150	nA
POWER-PATH	MANAGEMENT and INPUT	CURRENT LIMIT				
V <sub>DO(IN-PMID)</sub>	$V_{IN} - V_{(PMID)}$	V <sub>IN</sub> = 5 V, I <sub>IN</sub> = 300 mA		125	170	mV
V <sub>DO(BAT-PMID)</sub>	$V_{(BAT)} - V_{(PMID)}$	V <sub>IN</sub> = 0 V, V <sub>(BAT)</sub> > 3 V, I <sub>ff</sub> = 400 mA		120	160	mV
V <sub>(BSUP1)</sub>	Enter supplement mode threshold	$V_{(BAT)} > V_{(BUVLO)}$	,	√ <sub>(BAT)</sub> – 25		V
V <sub>(BSUP2)</sub>	Exit supplement mode threshold	$V_{(BAT)} > V_{(BUVLO)}$		V <sub>(BAT)</sub> –		V
I <sub>(BAT_OCP)</sub>	Current Limit, Discharge Mode	$V_{(BAT)} > V_{(BUVLO)}$	0.85	1.15	1.35	Α
	Input Current Limit	Programmable Range, 50-mA steps	50		400	mA
I <sub>(ILIM)</sub>	Maximum Input Current using ILIM					
()	I <sub>ILIM</sub> accuracy I <sub>ILIM</sub>	50 mA to 100 mA	-12%		12%	
	accuracy	100 mA to 400 mA	-5%		5%	
	Maximum input current	I <sub>(ILIM)</sub> = 50 mA to 100 mA	175	200	225	ΑΩ
K <sub>(ILIM)</sub>	factor	I <sub>(ILIM)</sub> = 100 mA to 400 mA	190	200	210	ΑΩ
V <sub>IN(DPM)</sub>	Input voltage threshold when input current is reduced	Programmable Range using V <sub>IN(DPM)</sub> Registers. Can be disabled using V <sub>IN(DPM_ON)</sub>	4.2		4.9	V
III(B) III)	V <sub>IN_DPM</sub> threshold accuracy		-3%	K <sub>(ILIM)</sub> / R <sub>(ILIM)</sub> 12% 5% 200 225 200 210 4.9		
BATTERY CHA	ARGER	· · · · · · · · · · · · · · · · · · ·		-		
R <sub>ON(BAT-PMID)</sub>	Internal Battery Charger MOSFET on-resistance	Measured from BAT to PMID, V <sub>(BAT)</sub> = 4.35 V, High-Z mode		300	400	mΩ
V	Charge Voltage	Operating in voltage regulation, Programmable Range, 10-mV steps	3.6		4.65	V
V <sub>(BATREG)</sub>	Voltage Regulation Accuracy	T <sub>J</sub> = 0°C to 85°C	-0.5%		0.5%	

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# 8.5 Electrical Characteristics (continued)

Circuit of Figure 8-1,  $V_{(UVLO)} < V_{IN} < V_{(OVP)}$  and  $V_{IN} > V_{(BAT)} + V_{(SLP)}$ ,  $T_J = -40^{\circ}C$  to 85°C and  $T_J = 25^{\circ}C$  for typical values (unless otherwise noted)

P/	ARAMETERS	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	Fast Charge Current Range	$V_{(BATUVLO)} \le V_{(BAT)} \le V_{(BATREG)}$	5		300	mA
I <sub>(CHARGE)</sub>	Fast Charge Current using ISET			K <sub>(ISET)</sub> / R <sub>(ISET)</sub>		А
	Fast Charge Current Accuracy		-5%		300 5% 210 37 10% 37 10% 140 850 475 40 675 850 200 3.3 2.5% 6.6 6.6 6.6 2% 3% 3.3 1% 60	
K <sub>(ISET)</sub>	Fast Charge Current Factor	5 mA > I <sub>(CHARGE)</sub> > 300 mA	190	200	210	ΑΩ
	Termination charge current	Termination current programmable range over I <sup>2</sup> C	0.5		37	mA
		$I_{(CHARGE)}$ < 300 mA, $R_{(ITERM)}$ = 15 k $\Omega$		5		% of I <sub>SET</sub>
I <sub>(TERM)</sub>	Termination Current	$I_{(CHARGE)}$ < 300 mA, $R_{(ITERM)}$ = 4.99 k $\Omega$		10		% of I <sub>SET</sub>
(,	using IPRETERM	$I_{(CHARGE)}$ < 300 mA, $R_{(ITERM)}$ = 1.65 k $\Omega$		15		% of I <sub>SET</sub>
		$I_{(CHARGE)}$ < 300 mA, $R_{(ITERM)}$ = 549 $\Omega$		20		% of I <sub>SET</sub>
PRE_CHARGE)  /(RCH)  DGL(RCHG)  SYS OUTPUT  RDS(ON_HS)	Accuracy	I <sub>(TERM</sub> ) > 4 mA	-10%		10%	
t <sub>DGL(TERM)</sub>	TERM deglitch time	Both rising and falling, 2-mV over-drive, t <sub>RISE</sub> , t <sub>FALL</sub> = 100 ns		64		ms
	Pre-charge current	Pre-charge current programmable range over I <sup>2</sup> C	0.5		37	mA
CHARGE)  CHARGE)  CHARGE)  CHERM)  CHARGE  CHA	Pre-charge Current using IPRETERM			I <sub>(TERM)</sub>		Α
	Accuracy		-10%		10%	
V <sub>(RCH)</sub>	Recharge threshold voltage	Below V <sub>(BATREG)</sub>	100	120	140	mV
t <sub>DGL(RCHG)</sub>	Recharge threshold deglitch time	t <sub>FALL</sub> = 100 ns typ, V <sub>(RCH)</sub> falling		32		ms
SYS OUTPUT						
R <sub>DS(ON_HS)</sub>		PMID = 3.6 V, I <sub>(SYS)</sub> = 150 mA		675	850	mΩ
R <sub>DS(ON_LS)</sub>		PMID = 3.6 V, I <sub>(SYS)</sub> = 150 mA		300	475	mΩ
R <sub>DS(CH_SYS)</sub>	MOSFET on-resistance for SYS discharge	$V_1N = 3.6 \text{ V}$ , $I_{OUT} = -10 \text{ mA}$ into $V_{OUT}$ pin		22	40	Ω
1	SW Current limit HS	2.2 V < V <sub>(PMID)</sub> < 5.5 V	450	600	675	mA
I(LIMF)	SW Current limit LS	2.2 V < V <sub>(PMID)</sub> < 5.5 V	450	700	850	mA
I <sub>(LIM_SS)</sub>	PMOS switch current limit during softstart	Current limit is reduced during softstart	80	130	200	mA
	SYS Output Voltage Range	Programmable range, 100 mV Steps	1.1		3.3	V
	Output Voltage Accuracy	V <sub>IN</sub> = 5 V, PFM mode, I <sub>OUT</sub> = 10 mA, V <sub>(SYS)</sub> = 1.8 V	-2.5%	0	300  (1)  5%  5%  210  37  6  10%  10%  140  2  5850  475  2 40  675  850  2 200  3.3  2.5%  6.6  6.6  6.6  6.6  6.7  2%  3%  3.3  1%	
$V_{SYS}$	DC Output Voltage Load Regulation in PWM mode	V <sub>OUT</sub> = 2 V, over load range		0.01		%/mA
	DC Output Voltage Line Regulation in PWM mode	V <sub>OUT</sub> = 2 V, I <sub>OUT</sub> = 100 mA, over V <sub>IN</sub> range		0.01		%/V
LS/LDO OUTPU	JT					
V	Input voltage range for LS/LDO	Load Switch Mode	0.8		6.6	V
VIN(LS)	Input voltage range for LS/LDO	LDO Mode	2.2		6.6	V
Vaur	DC output accuracy	T <sub>J</sub> = 25°C	-2%	±1%	2%	
▼ OUT	20 output accuracy	Over V <sub>IN</sub> , I <sub>OUT</sub> , temperature	-3%	±2%	3%	
V <sub>LDO</sub>	Output range for LS/LDO	Programmable Range, 0.1 V steps	0.8		3.3	V
A\/ / A\/	DC Line regulation	V <sub>OUT(NOM)</sub> + 0.5 V < V <sub>IN</sub> < 6.6 V, I <sub>OUT</sub> = 5 mA	-1%		1%	
Δv <sub>OUT</sub> / Δ v <sub>IN</sub>	DC Load regulation	0 mA < I <sub>OUT</sub> < 100 mA	-1%		1%	
	Load Transient	2 μA to 100 mA, VOUT = 1. 8 V	-120		60	mV



## 8.5 Electrical Characteristics (continued)

Circuit of Figure 8-1,  $V_{(UVLO)} < V_{IN} < V_{(OVP)}$  and  $V_{IN} > V_{(BAT)} + V_{(SLP)}$ ,  $T_J = -40^{\circ}C$  to 85°C and  $T_J = 25^{\circ}C$  for typical values (unless otherwise noted)

PA	RAMETERS	TEST CONDITIONS	MIN	TYP	MAX	UNIT
R <sub>(DSCH_LSLDO)</sub>	MOSFET on-resistance for LS/LDO discharge	1.7 V < V <sub>(VINLS)</sub> < 6.6 V, I <sub>LOAD</sub> = -10 mA		20		Ω
I <sub>(OCL_LDO)</sub>	Output Current Limit – LDO	V <sub>LS/LDO</sub> = 0 V	275	365	475	mA
		V <sub>(VINLS)</sub> = 3.6 V, V <sub>LSLDO</sub> = 3.3 V			100	mA
I <sub>(LS/LDO)</sub>	Output Current	V <sub>(VINLS)</sub> = 3.3 V, V <sub>LSLDO</sub> = 0.8 V			100	mA
		V <sub>(VINLS)</sub> = 2.2 V, V <sub>LSLDO</sub> = 0.8 V			10	mA
I <sub>IN(LDO)</sub>	Quiescent current for VINLS in LDO mode			0.9		μА
	OFF-state supply current			0.25		μA
V <sub>IH(LSCTRL)</sub>	High-level input voltage for LSCTRL	1.15 V > V <sub>(VINLS)</sub> > 6.6 V	0.75 x V <sub>(SYS)</sub>		6.6	V
V <sub>IL(LSCTRL)</sub>	Low-level input voltage for LSCTRL	1.15 V > V <sub>(VINLS)</sub> > 6.6 V			0.25 x V <sub>(SYS)</sub>	V
PUSHBUTTON 1	TIMER ( MR)					
V <sub>IL</sub>	Low-level input voltage	V <sub>BAT</sub> > V <sub>BUVLO</sub>			0.3	V
R <sub>PU</sub>	Internal pull-up resistance			120		kΩ
VBAT MONITOR	ł					
V <sub>BMON</sub>	Battery Voltage Monitor Accuracy	V <sub>(BAT)</sub> Falling - Including 2% increment	-3.5		3.5	%V <sub>(BATREG)</sub>
BATTERY-PACK	NTC MONITOR		•			
V <sub>HOT</sub>	High temperature threshold	V <sub>TS</sub> falling, 1% V <sub>IN</sub> Hysteresis	14.5	15	15.2	%V <sub>IN</sub>
V <sub>WARM</sub>	Warm temperature threshold	V <sub>TS</sub> falling, 1% V <sub>IN</sub> Hysteresis	20.1	20.5	20.8	%V <sub>IN</sub>
V <sub>COOL</sub>	Cool temperature threshold	V <sub>TS</sub> rising, 1% V <sub>IN</sub> Hysteresis	35.4	36	36.4	%V <sub>IN</sub>
V <sub>COLD</sub>	Low temperature threshold	V <sub>TS</sub> rising, 1% V <sub>IN</sub> Hysteresis	39.3	39.8	40.2	%V <sub>IN</sub>
TS <sub>OFF</sub>	TS Disable threshold	V <sub>TS</sub> rising, 2% V <sub>IN</sub> Hysteresis	55		60	%V <sub>IN</sub>
PROTECTION						
V <sub>(UVLO)</sub>	IC active threshold voltage	V <sub>IN</sub> rising	3.4	3.6	3.8	V
V <sub>UVLO(HYS)</sub>	IC active hysteresis	V <sub>IN</sub> falling from above V <sub>UVLO</sub>		150		mV
	Battery Undervoltage Lockout threshold Range	Programmable Range for V <sub>(BUVLO)</sub> VBAT falling, 150 mV Hysteresis	2.2		3.0	V
$V_{(BUVLO)}$	Default Battery Undervoltage Lockout Accuracy	V <sub>(BAT)</sub> falling	-2.5%		2.5%	
V <sub>(BATSHORT)</sub>	Battery short circuit threshold	Battery voltage falling		2		V
V <sub>(BATSHORT_HYS)</sub>	Hysteresis for V <sub>(BATSHORT)</sub>			100		mV
I <sub>(BATSHORT)</sub>	Battery short circuit charge current			I <sub>(PRETERM)</sub>		mA
V <sub>(SLP)</sub>	Sleep entry threshold, V <sub>IN</sub> – V <sub>(BAT)</sub>	2 V < V <sub>BAT</sub> < V <sub>(BATREG)</sub> , V <sub>IN</sub> falling		65	120	mV
V <sub>(SLP_HYS)</sub>	Sleep-mode exit hysteresis	V <sub>IN</sub> rising above V <sub>(SLP)</sub>	40	65	100	mV
V <sub>OVP</sub>	Maximum Input Supply OVP threshold voltage	V <sub>IN</sub> rising, 100 mV hysteresis	5.35	5.55	5.75	V
t <sub>DGL_OVP</sub>	Deglitch time, VIN OVP falling	V <sub>IN</sub> falling below V <sub>OVP</sub> , 1V/us		32		ms
T <sub>SHTDWN</sub>	Thermal trip	V <sub>IN</sub> > V <sub>UVLO</sub>		114		°C



# 8.5 Electrical Characteristics (continued)

Circuit of Figure 8-1,  $V_{(UVLO)} < V_{IN} < V_{(OVP)}$  and  $V_{IN} > V_{(BAT)} + V_{(SLP)}$ ,  $T_J = -40^{\circ}C$  to 85°C and  $T_J = 25^{\circ}C$  for typical values (unless otherwise noted)

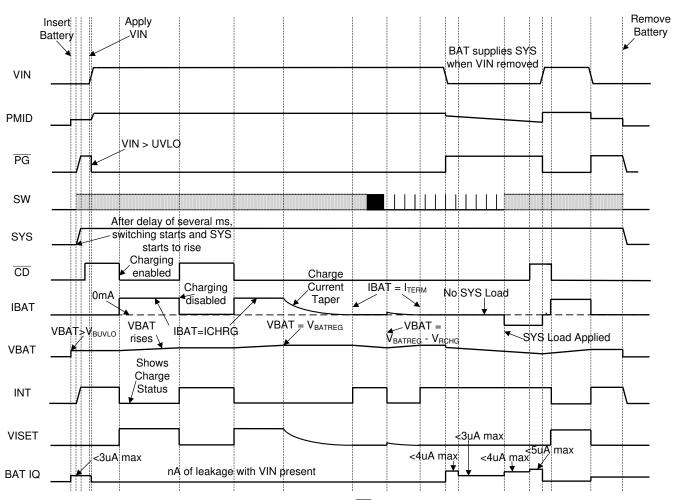
PARAMETERS		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
T <sub>HYS</sub>	Thermal hysteresis	V <sub>IN</sub> > V <sub>UVLO</sub>		11		°C	
t <sub>DGL_</sub> SHTDWN	Deglitch time, Thermal shutdown	T <sub>J</sub> rising above T <sub>SHTDWN</sub>		4		μs	
I2C INTERFAC	E						
	I <sup>2</sup> C Bus Specification standard and fast mode frequency support		100		400	kHz	
V <sub>IL</sub>	Input low threshold level	V <sub>PULLUP</sub> = 1.1 V, SDA and SCL			0.275	V	
V <sub>IH</sub>	Input high threshold level	V <sub>PULLUP</sub> = 1.1 V, SDA and SCL	0.825			V	
V <sub>IH</sub>	Input high threshold level	V <sub>PULLUP</sub> = 3.3 V, SDA and SCL	2.475			V	
V <sub>OL</sub>	Output low threshold level	IL = 5 mA, sink current, V <sub>PULLUP</sub> = 1.1 V		0.275		V	
I <sub>BIAS</sub>	High-Level leakage current	V <sub>PULLUP</sub> = 1.8 V, SDA and SCL			1	μΑ	
INT, PG, and R	ESET OUTPUT (Open Drain	n)					
V <sub>OL</sub>	Low level output threshold	Sinking current = 5 mA			0.25 x V <sub>(SYS)</sub>	V	
I <sub>IN</sub>	Bias current into pin	Pin is high impedance, I <sub>OUT</sub> = 0 mA; T <sub>J</sub> = -40°C to 60°C			12	nA	
V <sub>IN(BAT_DELTA)</sub>	Input voltage above VBAT where PG sends two 128 µs pulses each minute to signal the host of the input voltage status	V <sub>UVLO</sub> < V <sub>IN</sub> < V <sub>OVP</sub>	0.825	1	1.15	V	
INPUT PIN ( C	D LSCTRL)		•				
V <sub>IL(/CD_LSCTRL)</sub>	Input low threshold	V <sub>(PULLUP)</sub> = V <sub>SYS</sub> = 3.3 V		0.2	5 * V <sub>SYS</sub>	V	
V <sub>IH(/CD_LSCTRL)</sub>	Input high threshold	V <sub>(PULLUP)</sub> = V <sub>SYS</sub> = 3.3 V	0.75 * V <sub>SYS</sub>			V	
R <sub>PULLDOWN/CD</sub>	Internal pull-down resistance			900		kΩ	
R <sub>(LSCTRL)</sub>	Internal pull-down resistance			2		МΩ	



# 8.6 Timing Requirements

	·		MIN T	YP MAX	UNIT
POWER-PATH	I MANAGEMENT AND INPUT CURRENT L	IMIT			
t <sub>DGL_SC</sub>	Deglitch Time, PMID or SW Short Circuit during Discharge Mode		2	250	μs
t <sub>REC_SC</sub>	Recovery time, OUT Short Circuit during Discharge Mode			2	s
BATTERY CH	ARGER				
t <sub>DGL_SHORT</sub>	Deglitch time transition from ISET short to $I_{(CHARGE)}$ disable	Clear fault by disconnecting VIN		1	ms
BATTERY CH	ARGING TIMERS				
t <sub>MAXCHG</sub>	Charge safety timer	Programmable range	2	540	min
t <sub>PRECHG</sub>	Precharge safety timer		0.1 x t <sub>MAXC</sub>	CHG	
SYS OUTPUT					
t <sub>ONMIN</sub>	Minimum ON time	V <sub>IN</sub> = 3.6 V, V <sub>OUT</sub> = 2 V, I <sub>OUT</sub> = 0 mA	2	225	ns
t <sub>OFFMIN</sub>	Minimum OFF time	V <sub>IN</sub> = 4.2 V		50	ns
t <sub>START_SW</sub>	SW start up time	V <sub>IN</sub> = 5 V, from write on EN_SW_OUT until output starts to rise		5 25	ms
t <sub>START_SYS</sub>	SYS output time to start switching	From insertion of BAT > $V_{(BUVLO)}$ or $V_{IN} > V_{(UVLO)}$	3	350	μs
t <sub>SOFTSTART</sub>	Softstart time with reduced current limit		4	100 1200	μs
LS/LDO OUTF	PUT				
t <sub>ON_LDO</sub>	Turn ON time	100-mA load	5	500	μs
t <sub>OFF_LDO</sub>	Turn OFF time	100-mA load		5	μs
PUSHBUTTO	N TIMER				
t <sub>WAKE1</sub>	Push button timer wake 1		0.08	1	S
t <sub>WAKE2</sub>	Push button timer wake 2	Programmable Range for wake2 function	1	2	s
t <sub>RESET</sub>	Push button timer reset	Programmable Range for reset function	5	15	s
t <sub>RESET_D</sub>	Reset pulse duration		4	100	ms
t <sub>DD</sub>	Detection delay (from MR, input to RESET)	For 0s condition		6	μs
BATTERY-PAG	CK NTC MONITOR				
t <sub>DGL(TS)</sub>	Deglitch time on TS change	Applies to $V_{(HOT)}$ , $V_{(WARM)}$ , $V_{(COOL)}$ , and $V_{(COLD)}$		50	ms
I2C INTERFAC	DE .				
t <sub>I2CRESET</sub>	I <sup>2</sup> C interface inactive reset timer		7	700	ms
t <sub>HIZ_ACTIVEBAT</sub>	Transition time required to enable the I <sup>2</sup> C interface from HiZ to Active BAT			1	ms
INPUT PIN	-				
t <sub>/CD_DGL</sub>	Deglitch for $\overline{\text{CD}}$	CD rising/falling	1	00	μs
t <sub>QUIET</sub>	Input quiet time for Ship Mode transition			1	ms

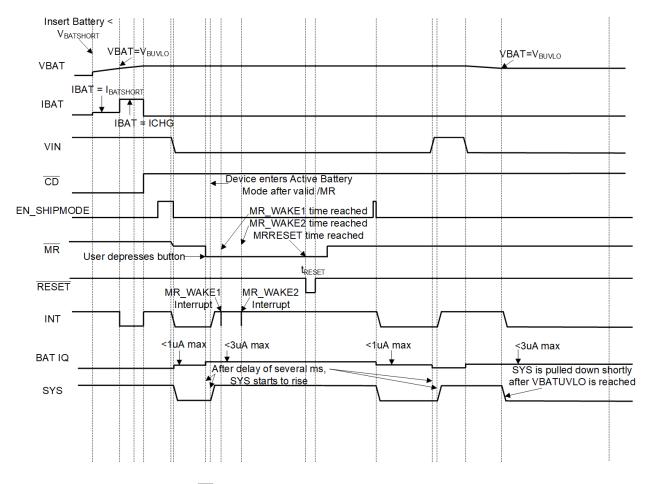
# Typical Start-Up Timing and Operation



Conditions: PGB\_MRS = 0, TE = 1, SW\_LDO = 1, VINDPM\_ON = 0,  $\overline{PG}$  and INT pulled up to SYS, EN\_INT = 1

Figure 8-1. Typical Start-Up Timing and Operation



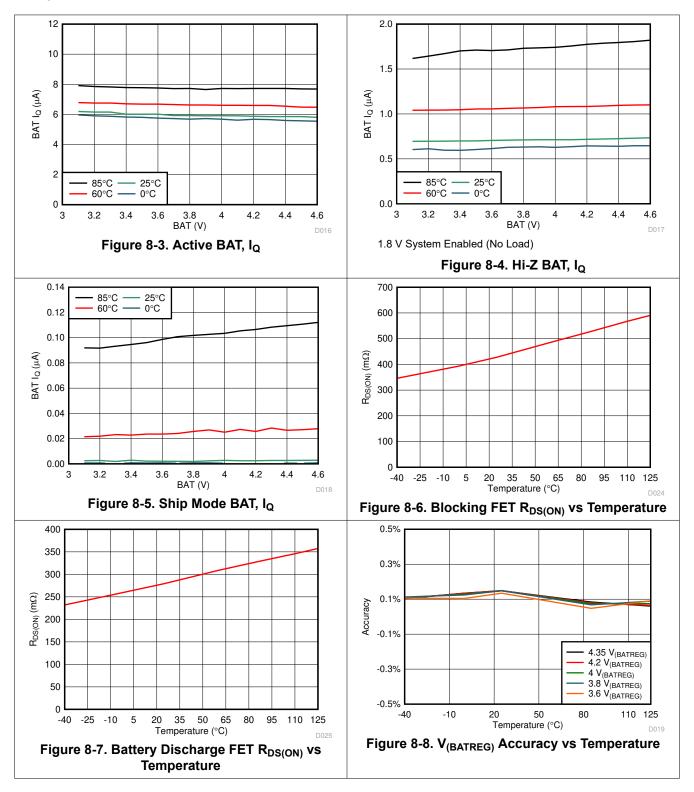


Conditions: SW\_LDO = 1, MRREC = 1,  $\overline{PG}$  and INT pulled up to SYS, ISYS = 10  $\mu$ A, EN\_INT = 1

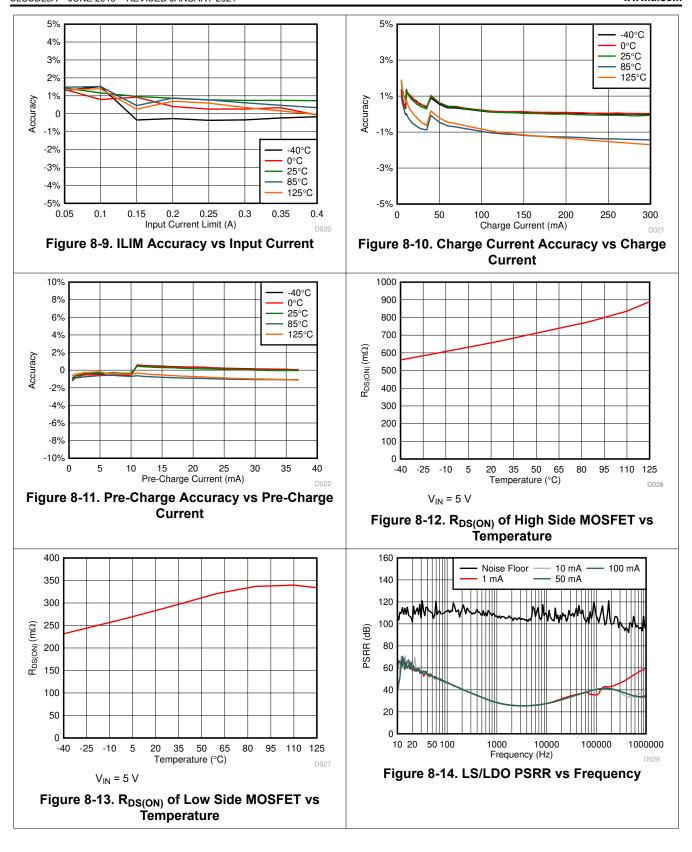
Figure 8-2. Battery Operation and Sleep Mode



## 8.7 Typical Characteristics







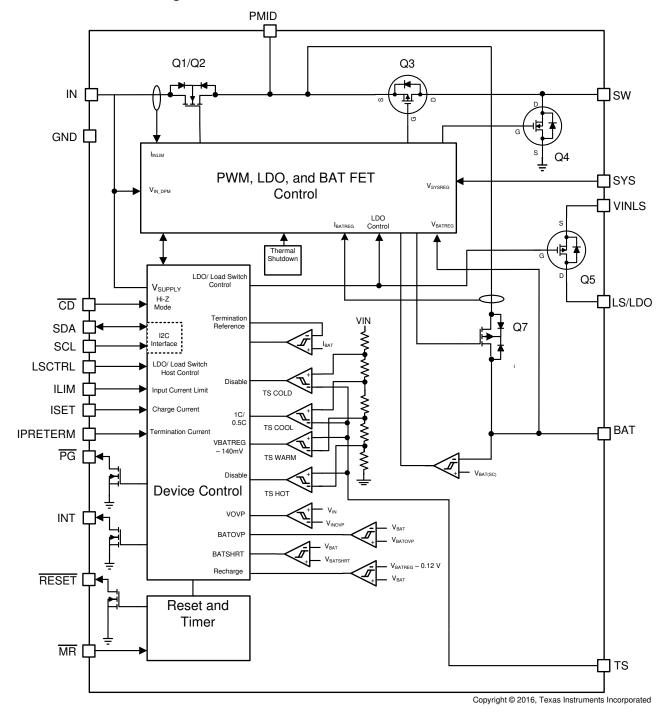


## 9 Detailed Description

## 9.1 Overview

The following sections describe in detail the functions provided by the BQ25125. These include linear charger, PWM output, configurable LS/LDO output, Push-button input, reset timer, functional modes, battery monitor, I<sup>2</sup>C configurability and functions, and safety features.

## 9.2 Functional Block Diagram



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## 9.3 Feature Description

#### 9.3.1 Ship Mode

Ship Mode is the lowest quiescent current state for the device. Ship Mode latches off the device and BAT FET until  $V_{IN} > V_{BAT} + V_{SLP}$  or the  $\overline{MR}$  button is depressed for  $t_{WAKE1}$  and released. The following list shows the events that are active during Ship Mode:

- 1. VIN\_UV Comparator
- 2. MR Input (No clock or delay in this mode for lowest power consumption)
- 3. PMID active pull down

#### 9.3.1.1 Ship Mode Entry and Exit

The device may only enter Ship Mode when there is not a valid VIN supply present ( $V_{IN} < V_{UVLO}$ ). Once the IN supply is removed there are two ways for the device to enter Ship Mode: through I<sup>2</sup>C command using the EN\_SHIPMODE bit and by doing a long button press when MRREC bit is set to 0. If the EN\_SHIPMODE bit is set while the IN supply is present, the device will enter Ship Mode upon removal of the supply. The EN\_SHIPMODE bit can be cleared using the I<sup>2</sup>C interface as well while the IN input is valid.

In addition to  $V_{IN} < V_{UVLO}$ ,  $\overline{CD}$  and  $\overline{MR}$  must be high. Once all of these conditions are met the device will begin the transition to Ship Mode. All three conditions must remain unchanged for a period of  $t_{QUIET}$  to ensure proper operation. Figure 9-1 and Figure 9-2 show the correct sequencing to ensure proper entry into the Ship Mode through  $I^2C$  command and  $\overline{MR}$  button press respectively.

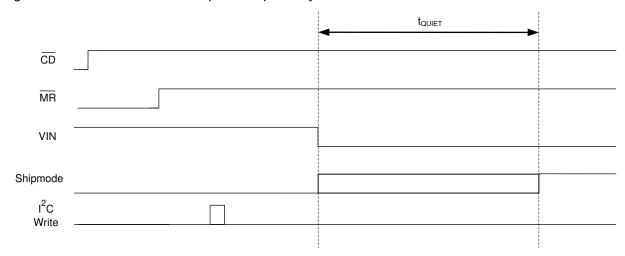


Figure 9-1. CD, MR and VIN Sequencing for Ship Mode Entry Through I<sup>2</sup>C Command

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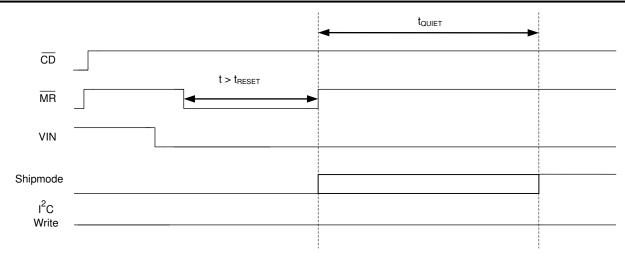


Figure 9-2. CD, MR and VIN Sequencing for Ship Mode Entry Through Long MR button press

The end user can enable the device (exit Ship Mode) by connecting an adapter to IN ( $V_{IN} > V_{BAT} + V_{SLP}$ ) or by toggling the  $\overline{MR}$  button. Note that in the case where an adapter is connected while the  $\overline{MR}$  is still held low and immediately after the RESET timer has expired ( $\overline{MR}$  low for  $t_{RESET}$ ), the device will not enter Ship Mode, but may enter it upon adapter removal (Same behavior as setting the EN\_SHIPMODE bit when the adapter is present). This will not be the case if  $\overline{MR}$  has gone high when the adapter is connected or  $\overline{MR}$  continues to be held low for a period longer than  $t_{WAKE1}$  after the adapter is connected.

To exit Ship Mode through and  $\overline{MR}$  press the battery voltage must be above the maximum programmable BUVLO threshold when  $V_{IN}$  is not present. Once  $\overline{MR}$  goes low, the device will start to exit Ship Mode, powering PMID. The device will not complete the transition from Ship Mode until  $\overline{MR}$  has been held low for at least  $t_{WAKE1}$ . Only after the transition is complete may the host start  $I^2C$  communication if the device has not entered High Impedance Mode.

#### 9.3.2 High Impedance Mode

High Impedance mode is the lowest quiescent current state while operating from the battery. During Hi-Z mode the SYS output is powered by BAT, the  $\overline{\text{MR}}$  input is active, and the LSCTRL input is active. All other circuits are in a low power or sleep state. The LS/LDO output can be enabled in Hi-Z mode with the LSCTRL input. If the LS/LDO output has been enabled through I²C prior to entering Hi-Z mode, it will stay enabled. The  $\overline{\text{CD}}$  pin is used to put the device in a high-impedance mode when battery is present and  $V_{\text{IN}} < V_{\text{UVLO}}$ . Drive  $\overline{\text{CD}}$  high to enable the device and enter active battery operation when  $V_{\text{IN}}$  is not valid. When the HZ\_MODE bit is written by the host, the I²C interface is disabled if only battery is present. To resume I²C, the  $\overline{\text{CD}}$  pin must be toggled. If the supply for the  $\overline{\text{CD}}$  pull up glitches or experiences a brownout condition , it is recommended to toggle the /CD pin to resume I²C communication.. The functionality of the pin is shown in Table 9-1.

Table 9-1. CD, State Table

CD, STATE	V <sub>IN</sub> < V <sub>UVLO</sub>	V <sub>IN</sub> > V <sub>UVLO</sub>	
L	Hi-Z	Charge Enabled	
Н	Active Battery	Charge Disabled	

#### 9.3.3 Active Battery Only Connected

When the battery above  $V_{BATUVLO}$  is connected with no input source, the battery discharge FET is turned on. After the battery rises above  $V_{BATUVLO}$  and the deglitch time is reached, the SYS output starts to rise. The current from PMID and SYS is not regulated, but is protected by a short circuit current limit. If the short circuit limit is reached for the deglitch time ( $t_{DGL\_SC}$ ), the battery discharge FET is turned off for the recovery time ( $t_{REC\_SC}$ ). After the recovery time, the battery FET is turned on to test if the short has been removed. If it has not, the FET turns off and the process repeats until the short is removed. This process protects the internal FET from over current. During this event PMID will likely droop and cause SYS to go out of regulation.



To provide designers the most flexibility in optimizing their system, an adjustable BATUVLO is provided. When the voltage drops below the  $V_{BATUVLO}$  threshold, the battery discharge FET is turned off. Deeper discharge of the battery enables longer times between charging, but may shorten the battery life. The BATUVLO is adjustable with a fixed 150-mV hysteresis.

If a valid  $V_{IN}$  is connected during active battery mode,  $V_{IN} > V_{UVLO}$ , the supplement and battery discharge FET is turned on when the battery voltage is above the minimum  $V_{BATUVLO}$ .

Drive  $\overline{CD}$  high or write the CE register to disable charge when  $V_{IN} > V_{UVLO}$  is present.  $\overline{CD}$  is internally pulled down. When exiting this mode, charging resumes if  $V_{IN}$  is present,  $\overline{CD}$  is low and charging is enabled.

All HOST interfaces ( $\overline{CD}$ , SDA/SCL, INT,  $\overline{RESET}$  and LSCTRL) are active no later than 5 ms after SYS reaches the programmed level.

#### 9.3.4 Voltage Based Battery Monitor

The device implements a simple voltage battery monitor which can be used to determine the depth of discharge. Prior to entering High-Z mode, the device will initiate a VBMON reading. The host can read the latched value for the no-load battery voltage, or initiate a reading using VBMON\_READ to see the battery voltage under a known load. The register will be updated and can be read 2ms after a read is initiated. The VBMON voltage threshold is readable with 2% increments with ±1.5% accuracy between 60% and 100% of VBATREG using the VBMON\_TH registers. Reading the value during charge is possible, but for the most accurate battery voltage indication, it is recommended to disable charge, initiate a read, and then re-enable charge.

A typical discharge profile for a Li-Ion battery is shown in Table 9-2. The specific battery to be used in the application should be fully characterized to determine the thresholds that will indicate the appropriate battery status to the user. Two typical examples are shown below, assuming the VBMON reading is taken with no load on the battery.

This function enables a simple 5-bar status indicator with the following typical performance with different VBATREG settings:

Table 9-2. Discharge Profile for a Li-lon Battery

VBATREG	BATTERY FULL	95% to 65% REMAINING CAPACITY	65% to 35% REMAINING CAPACITY	35% to 5% REMAINING CAPACITY	BATTERY EMPTY
4.35 V	VBMON > 90%	VBMON = 88%	VBMON = 86%	VBMON = 84%	VBMON < 82%
4.2 V	VBMON > 98%	VBMON = 94% or 96%	VBMON = 90% or 92%	VBMON = 86% or 88%	VBMON < 84%

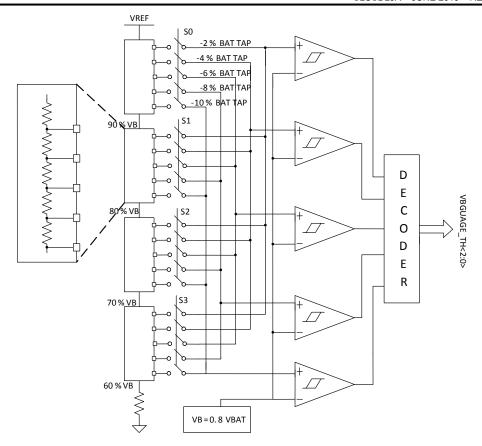


Figure 9-3. Voltage Battery Monitor

#### 9.3.5 Sleep Mode

The device enters the low-power sleep mode if the voltage IN falls below the sleep-mode entry threshold and  $V_{IN}$  is higher than the undervoltage lockout threshold. In sleep mode, the input is isolated from the connected battery. This feature prevents draining the battery during the absence of  $V_{IN}$ . When  $V_{IN} < V_{(BAT)} + V_{SLP}$ , the device turns the battery discharge FET on, sends a 128-µs pulse on the INT output, and the FAULT bits of the register are update over  $I^2C$ . Once  $V_{IN} > V_{(BAT)} + V_{SLP}$ , the device initiates a new charge cycle. The FAULT bits are not cleared until they are read over  $I^2C$  and the sleep condition no longer exists. It is not recommended to do a battery connection or plug in when  $V_{UVLO} < VIN < V_{BAT} + V_{SLP}$  as it may cause higher quiescent current to be drained form the battery.

## 9.3.6 Input Voltage Based Dynamic Power Management (V<sub>IN(DPM)</sub>)

During the normal charging process, if the input power source is not able to support the programmed or default charging current and System load, the supply voltage decreases. Once the supply approaches  $V_{IN(DPM)}$ , the input DPM current and voltage loops will reduce the input current through the blocking FETs, to prevent the further drop of the supply. The  $V_{IN(DPM)}$  threshold is programmable through the I²C register from 4.2 V to 4.9 V in 100-mV steps. It can be disabled completely as well. When the device enters this mode, the charge current may be lower than the set value and the VINDPM\_STAT bit is set. If the 2X timer is set, the safety timer is extended while  $V_{IN(DPM)}$  is active. Additionally, termination is disabled. Note that in a condition where the battery is connected while  $V_{UVLO} < V_{IN} < V_{IN(DPM)}$ , the VINDPM loop will prevent the battery from being charged and PMID will be powered from BAT.

Note that VINDPM is disabled by default on powerup under completely discharged battery to support low adapter voltage charging. It can be enabled through I2C once either adapter or battery voltage is present.

#### 9.3.7 Input Overvoltage Protection and Undervoltage Status Indication

The input overvoltage protection protects the device and downstream components connected to PMID, SYS, and BAT against damage from overvoltage on the input supply. When  $V_{IN} > V_{OVP}$  an OVP fault is determined to exist. During the OVP fault, the device turns the battery discharge FET on, sends a single 128- $\mu$ s pulse on INT, and the FAULT bits are updated over I<sup>2</sup>C. Once the OVP fault is removed, after the deglitch time,  $t_{DGL_OVP}$ , STAT and FAULT bits are cleared and the device returns to normal operation. The FAULT bits are not cleared until they are read in from I<sup>2</sup>C after the OVP condition no longer exists. The OVP threshold for the device is set to operate from standard USB sources.

The input under-voltage status indication is used to notify the host or other device when the input voltage falls below a desired threshold. When  $V_{IN} < V_{UVLO}$ , after the deglitch time  $t_{DGL\_UVLO}$ , a UVLO fault is determined to exist. During the  $V_{IN}$  UVLO fault, the device sends a single 128- $\mu$ s pulse on INT, and the STAT and FAULT bits are updated over I<sup>2</sup>C. The FAULT bits are not cleared until they are read in from I<sup>2</sup>C after the UVLO condition no longer exists.

#### 9.3.8 Battery Charging Process and Charge Profile

When a valid input source is connected ( $V_{IN} > V_{UVLO}$  and  $V_{(BAT)} + V_{SLP} < V_{IN} < V_{OVP}$  and  $V_{IN} > V_{IN(DPM)}$ ), the  $\overline{CE}$  bit in the control register determines whether a charge cycle is initiated. When the  $\overline{CE}$  bit is 1 and a valid input source is connected, the battery discharge FET is turned off, and the output at SYS is regulated depending on the output configuration. A charge cycle is initiated when the  $\overline{CE}$  bit is written to a 0. Alternatively, the  $\overline{CD}$  input can be used to enable and disable charge.

The device supports multiple battery chemistries for single-cell applications. Charging is done through the internal battery MOSFET. There are several loops that influence the charge current: constant current loop (CC), constant voltage loop (CV), input current limit, and  $V_{IN(DPM)}$ . Note that VDPPM loop feature found on similar chargers is disabled by default. During the charging process, all loops are enabled and the one that is dominant takes control.

The charge current is regulated to  $I_{CHARGE}$  until the voltage between BAT and GND reaches the regulation voltage. The voltage between BAT and GND is regulated to  $V_{BATREG}$  (CV Mode) while the charge current naturally tapers down. When termination is enabled, the device monitors the charging current during the CV mode, and once the charge current tapers down to the termination threshold,  $I_{TERM}$ , and the battery voltage is above the recharge threshold, the device terminates charge, and turns off the battery charging FET. Termination is disabled when any loop is active other than CV.

#### 9.3.9 Battery Supplement Mode

If the charging current falls to zero and the system load current increases beyond the programmed input current limit, the voltage at PMID reduces further. When the PMID voltage drops below the battery voltage by  $V_{(BSUP1)}$ , the battery supplements the system load. The battery stops supplementing the system load when the voltage on the PMID pin rises above the battery voltage by  $V_{(BSUP2)}$ . During supplement mode, the battery supplement current is not regulated, however, the short-circuit protection circuit is active. Battery termination is disabled while in supplement mode.

#### 9.3.10 Default Mode

The default mode is used when there is no host, or  $I^2C$  communication is not available. If the externally programmable pins, ILIM, ISET, and ITERM have resistors connected, that is considered the default mode. If any one of these resistors is tied to GND, the default register settings are used. The default mode can be entered by connecting a valid power source to  $V_{IN}$  or the RESET bit is written. Default mode is exited by writing to the  $I^2C$  interface.

## 9.3.11 Termination and Pre-Charge Current Programming by External Components (IPRETERM)

The termination current threshold is user programmable through an external resistor or through registers over  $I^2C$ . Set the termination current using the IPRETERM pin by connecting a resistor from IPRETERM to GND. The termination can be set between 5% and 20% of the programmed output current set by ISET, using Table 9-3 for guidance:

**Table 9-3. IPRETERM Resistor Settings** 

IPR	IPRE_CHARGE and ITERM		_				RIPRETERM (STANDARD 1% VALUES)	UNIT
MIN	TYP (% of ISET)	MAX	MIN	MIN TYP MAX R		RECOMMENDED RIPRETERM		
	5		180	200	220	15000	Ω	
	10		180	200	220	4990	Ω	
	15		180	200	220	1650	Ω	
	20		180	200	220	549	Ω	

Using the  $I^2C$  register, the termination current can be programmed with a minimum of 500  $\mu A$  and a maximum of 37 mA.

The pre-charge current is not independently programmable through the external resistor, and is set at the termination current. The pre-charge and termination currents are programmable using the IPRETERM registers. If no IPRETERM resistor is connected and the pin is tied to GND, the default values in the IPRETERM registers are used. The external value can be used in host mode by configuring the IPRETERM registers. If the external ICHG setting will be used after being in Host mode, the IPRETERM registers should be set to match the desired external threshold for the highest ICHG accuracy.

Termination is disabled when any loop other than CV is active.

#### 9.3.12 Input Current Limit Programming by External Components (ILIM)

The input current limit threshold is user programmable through an external resistor or through registers over I<sup>2</sup>C. Set the input current limit using the ILIM pin by connecting a resistor from ILIM to GND using Table 9-4 for guidance. If no ILIM resistor is connected and the pin is tied to GND, the default ILIM register value is used. The external value is not valid once the device enters host mode.

**Table 9-4. ILIM Resistor Settings** 

	ILIM			KILIM		RILIM	
MIN	TYP	MAX	MIN	TYP	MAX	(STANDARD 1% VALUES)	UNIT
0.048469388	0.051020408	0.053571429	190	200	210	3920	Ω
0.09047619	0.095238095	0.1	190	200	210	2100	Ω
0.146153846	0.153846154	0.161538462	190	200	210	1300	Ω
0.19	0.2	0.21	190	200	210	1000	Ω
0.285714286	0.30075188	0.315789474	190	200	210	665	Ω
0.380761523	0.400801603	0.420841683	190	200	210	499	Ω

The device has register programmable input current limits from 50 mA to 400 mA in 50-mA steps. The device is USB-IF compliant for inrush current testing, assuming that the input capacitance to the device is selected to be small enough to prevent a violation ( $<10 \mu F$ ), as this current is not limited.

### 9.3.13 Charge Current Programming by External Components (ISET)

The fast charge current is user programmable through an external resistor or through registers over  $I^2C$ . Set the fast charge current by connecting a resistor from ISET to GND. If no ISET resistor is connected and the pin is tied to GND, the default ISET register value is used. While charging, if the charge current is using the externally programmed value, the voltage at ISET reflects the actual charging current and can be used to monitor charge current. The current out of ISET is 1/100 ( $\pm 10\%$ ) of the charge current. The charge current can be calculated by using Table 9-5 for guidance:

**Table 9-5. ISET Resistor Settings** 

	ISET			KISET		RISET	
MIN	TYP	MAX	MIN	TYP	MAX	(STANDARD 1% VALUES)	UNIT
0.285714286	0.30075188	0.315789474	190	200	210	665	Ω
0.19	0.2	0.21	190	200	210	1000	Ω
0.126666667	0.133333333	0.14	190	200	210	1500	Ω
0.095	0.1	0.105	190	200	210	2000	Ω
0.06462585	0.068027211	0.071428571	190	200	210	2940	Ω
0.048469388	0.051020408	0.053571429	190	200	210	3920	Ω
0.038076152	0.04008016	0.042084168	190	200	210	4990	Ω
0.031456954	0.033112583	0.034768212	190	200	210	6040	Ω
0.025956284	0.027322404	0.028688525	190	200	210	7320	Ω
0.019	0.02	0.021	190	200	210	10000	Ω
0.012666667	0.013333333	0.014	190	200	210	15000	Ω
0.0095	0.01	0.0105	190	200	210	20000	Ω
0.006462585	0.006802721	0.007142857	190	200	210	29400	Ω
0.004846939	0.005102041	0.005357143	190	200	210	39200	Ω



#### 9.3.14 Safety Timer

At the beginning of the charge cycle, the device starts the safety timer. If charging has not terminated before the programmed safety time,  $t_{MAXCHG}$ , expires, the device enters idle mode and charging is disabled. The pre-charge safety time,  $t_{PRECHG}$ , is 10% of  $t_{MAXCHG}$ . When a safety timer fault occurs, a single 128 µs pulse is sent on the INT pin and the STAT and FAULT bits of the status registers are updated over  $I^2C$ . The  $\overline{CD}$  pin or power must be toggled in order to clear the safety timer fault. The safety timer duration is programmable using the TMR bits. When the safety timer is active, changing the safety timer duration resets the safety timer. The device also contains a 2X\_TIMER bit that enables the 2X timer function to prevent premature safety timer expiration when the charge current is reduced by a load on PMID, SYS, LS/LDO or a NTC condition. When  $t_{2X_TIMER}$  function is enabled, the timer is allowed to run at half speed when any loop is active other than CC or  $t_{2X_TIMER}$ 

In addition to the safety timer, the device contains a 50-second watchdog timer that monitors the host through the I2C interface. Only after an I<sup>2</sup>C transaction is performed on the I<sup>2</sup>C interface, will the watchdog timer start. In the case where the device is set to operate in High Impedance Mode, the watchdog timer is automatically disabled and can only be re-started after the device exits the High Impedance Mode and a subsequent I<sup>2</sup>C transaction is performed. The watchdog timer is reset by any transaction by the host using the I<sup>2</sup>C interface. If the watchdog timer expires without a reset from the I<sup>2</sup>C interface, all registers except MRRESET\_VIN and MRREC are reset to the default values.

## 9.3.15 External NTC Monitoring (TS)

The I<sup>2</sup>C interface allows the user to easily implement the JEITA standard for systems where the battery pack thermistor is monitored by the host. Additionally, the device provides a flexible voltage based TS input for monitoring the battery pack NTC thermistor. The voltage at TS is monitored to determine that the battery is at a safe temperature during charging.

To satisfy the JEITA requirements, four temperature thresholds are monitored: the cold battery threshold, the cool battery threshold, the warm battery threshold, and the hot battery threshold. These temperatures correspond to the  $V_{(COLD)}$ ,  $V_{(COLD)}$ ,  $V_{(WARM)}$ , and  $V_{(HOT)}$  threshold in the Section 8.5. Charging and timers are suspended when  $V_{(TS)} < V_{(HOT)}$  or  $> V_{(COLD)}$ . When  $V_{(COLD)} < V_{(TS)} < V_{(COLD)}$ , the charging current is reduced to half of the programmed charge current. When  $V_{(HOT)} < V_{(TS)} < V_{(WARM)}$ , the battery regulation voltage is reduced by 140 mV (minimum  $V_{BATREG}$  under this condition is 3.6V).

The TS function is voltage based for maximum flexibility. Connect a resistor divider from  $V_{IN}$  to GND with TS connected to the center tap to set the threshold. The connections are shown in Figure 9-4. The resistor values are calculated using Equation 1 and Equation 2. To disable the TS function, pull TS above TS<sub>OFF</sub> threshold.

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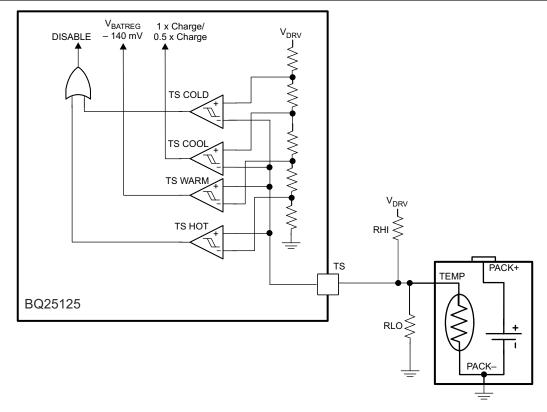


Figure 9-4. TS Circuit

$$R_{(LO)} = \frac{V_{IN} \times R_{(COLD)} \times R_{(HOT)} \times \left(\frac{1}{V_{(COLD)}} - \frac{1}{V_{(HOT)}}\right)}{R_{(HOT)} \times \left(\frac{V_{IN}}{V_{(HOT)}} - 1\right) - R_{(COLD)} \times \left(\frac{V_{IN}}{V_{(COLD)}} - 1\right)}$$
(1)

$$R_{(HI)} = \frac{\left(\frac{V_{IN}}{V_{(COLD)}} - 1\right)}{\left(\frac{1}{R_{(LO)}} + \frac{1}{R_{(COLD)}}\right)}$$
(2)

#### Where

- R<sub>(HOT)</sub> = the NTC resistance at the hot temperature
- R<sub>(COLD)</sub> = the NTC resistance at the cold temperature

The warm and cool thresholds are not independently programmable. The cool and warm NTC resistances for a selected resistor divider are calculated using Equation 3 and Equation 4.

$$R_{(COOL)} = \frac{R_{(LO)} \times R_{(HI)} \times V_{(COOL\%)}}{R_{(LO)} - ((R_{(LO)} \times V_{(COOL\%)}) - (R_{(HI)} \times V_{(COOL\%)}))}$$
(3)

$$R_{(WARM)} = \frac{R_{(LO)} \times R_{(HI)} \times V_{(WARM\%)}}{R_{(LO)} - \left( \left( R_{(LO)} \times V_{(WARM\%)} \right) - \left( R_{(HI)} \times V_{(WARM\%)} \right) \right)}$$
(4)

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#### 9.3.16 Thermal Protection

During the charging process, to prevent overheating in the device, the junction temperature of the die, T<sub>J</sub>, is monitored. When T<sub>J</sub> reaches T<sub>(SHUTDOWN)</sub> the device stops charging, disables the PMID output, disables the SYS output, and disables the LS/LDO output. During the time that T(SHUTDOWN) is exceeded, the safety timer is reset. The charge cycle resumes when T<sub>J</sub> falls below T<sub>(SHUTDOWN)</sub> by T<sub>(HYS)</sub>.

To avoid reaching thermal shutdown, ensure that the system power dissipation is under the limits of the device. The power dissipated by the device can be calculated using Equation 5.

$$P_{DISS} = P_{(BLOCK)} + P_{(SYS)} + P_{(LS/LDO)} + P_{(BAT)}$$
(5)

- $$\begin{split} & P_{(BLOCK)} = (V_{IN} V_{(PMID)}) \times I_{IN} \\ & P_{(SYS)} = I_{SYS}^{2} \times R_{DS(ON\_HS)} \\ & P_{(LS/LDO)} = (V_{(INLS)} V_{(LS/LDO)}) \times I_{(LS/LDO)} \\ & P_{(BAT)} = (V_{(PMID)} V_{(BAT)}) \times I_{(BAT)} \end{split}$$

## 9.3.17 Typical Application Power Dissipation

The die junction temperature, T<sub>J</sub>, can be estimated based on the expected board performance using Equation 6.

$$T_{J} = T_{A} + \theta_{JA} \times P_{DISS} \tag{6}$$

The  $\theta_{JA}$  is largely driven by the board layout. For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report. Under typical conditions, the time spent in this state is short.

## 9.3.18 Status Indicators ( PG and INT)

The device contains two open-drain outputs that signal its status and are valid only after the device has completed start-up into a valid state. If the part starts into a fault, interrupts will not be sent. The PG output signals when a valid input source is connected.  $\overline{PG}$  pulls to GND when  $V_{IN} > V_{UVLO}$ ,  $V_{IN} > V_{BAT} + V_{SLP}$  and  $V_{IN} < V_{IN} > V_{IN} >$ V<sub>OVP</sub>. PG is high-impedance when the input power is not within specified limits. Connect PG to the desired logic voltage rail using a 1-k $\Omega$  to 100-k $\Omega$  resistor, or use with an LED for visual indication.

The  $\overline{PG}$  pin can be configured as a  $\overline{MR}$  shifted (MRS) output when the PGB MRS bit is set to 1.  $\overline{PG}$  is high-impedance when the  $\overline{MR}$  input is not low, and  $\overline{PG}$  pulls to GND when the  $\overline{MR}$  input is below  $V_{OL(TH\ MRS)}$ . Connect  $\overline{PG}$  to the desired logic voltage rail using a 1-k $\Omega$  to 100-k $\Omega$  resistor.

The INT pin is pulled low during charging when the EN INT bit is set to 1 and interrupts are pulled high. When EN INT is set to 0, charging status is not indicated on the INT pin. When charge is complete or disabled, INT is high impedance. The charge status is valid whether it is the first charge or recharge. When a fault occurs, a 128 μs pulse (interrupt) is sent on INT to notify the host.

## 9.3.19 Chip Disable ( CD)

The device contains a  $\overline{\text{CD}}$  input that is used to disable the device and place it into a high impedance mode when only battery is present. In this case, when  $\overline{\text{CD}}$  is low, PMID and SYS remain active, and the battery discharge FET is turned on. If the LS/LDO output has been enabled prior to pulling CD low, it will stay on. The LSCTRL pin can also enable/disable the LS/LDO output when the  $\overline{CD}$  pin is pulled low. The  $\overline{CD}$  pin has an internal pull-down.

If  $V_{IN}$  is present and the  $\overline{CD}$  input is pulled low, charge is enabled and all other functions remain active. If  $V_{IN}$  is present and the  $\overline{\text{CD}}$  input is pulled high, charge is disabled.

## 9.3.20 Buck (PWM) Output

The device integrates a low quiescent current switching regulator with DCS control allowing high efficiency down to 10-µA load currents. DCS control combines the advantages of hysteretic and voltage mode control. The internally compensated regulation network achieves fast and stable operation with small external components and low ESR capacitors. During PWM mode, it operates in continuous conduction mode, with a frequency up to 2 MHz. If the load current decreases, the converter enters a power save mode to maintain high efficiency down

to light loads. In this mode, the device generates a single switching pulse to ramp up the inductor current and recharge the output capacitor, followed by a sleep period where most of the internal circuits are shut down to achieve a low quiescent current. The duration of the sleep period depends on the load current and the inductor peak current. For optimal operation and maximum power delivery allow  $V_{PMID} > V_{SYS} + 0.7V$ .

The output voltage is programmable using the SYS\_SEL and SYS\_VOUT bits in the SYS VOUT control register.

The SW output is enabled using the EN\_SYS\_OUT bit in the register. This bit is for testing and debug only and not intended to be used in the final system. When the device is enabled, the internal reference is powered up and the device enters softstart, starts switching, and ramps up the output voltage. When SW is disabled, the output is in shutdown mode in a low quiescent state. The device provides automatic output voltage discharge so the output voltage will ramp up from zero once the device in enabled again. Once SYS has been disabled, either  $V_{IN}$  needs to be connected or the  $\overline{MR}$  button must be held low for the  $t_{RESET}$  duration to re-enable SYS.

The output is optimized for operation with a 2.2-µH inductor and 10-µF output capacitor. Table 9-6 shows the recommended LC output filter combinations.

Table 9-6. Recommended Output Filter

INDUCTOR VALUE (µH)	OUTPUT CAPACITOR VALUE (μF)					
	4.7 10 22					
2.2	Possible Recommended Possible					

The inductor value affects the peak-to-peak ripple current, the PWM-to-PFM transition point where the part enters and exits Pulse Frequency Modulation to lower the power consumed at low loads, the output voltage ripple and the efficiency. The selected inductor must be selected for its DC resistance and saturation current. The inductor ripple current ( $\Delta I_1$ ) can be estimated according to Equation 7.

$$\Delta I_{L} = V_{SYS} \times (1 - (V_{SYS}/V_{PMID}))/(L \times f)$$
(7)

Use Equation 8 to calculate the maximum inductor current under static load conditions. The saturation current of the inductor should be rated higher than the maximum inductor current. As the size of the inductor decreases, the saturation "knee" must be carefully considered to ensure that the inductance does not decrease during higher load condition or transient. This is recommended because during a heavy load transient the inductor current rises above the calculated value. A more conservative way is to select the inductor saturation current above the high-side MOSFET switch current.

$$I_{L}(max) = I_{SYS}(max) + \Delta I_{L} / 2 \tag{8}$$

#### Where

- F = Switching Frequency
- L = Inductor Value
- ΔI<sub>L</sub> = Peak to Peak inductor ripple current
- I<sub>L</sub>(max) = Maximum Inductor current

In DC/DC converter applications, the efficiency is affected by the inductor AC resistance and by the inductor DCR value.

Table 9-7 shows recommended inductor series from different suppliers.

**Table 9-7. Inductor Series** 

INDUCTANCE (µH)	DCR (Ω)	DIMENSIONS (mm³)	INDUCTOR TYPE	SUPPLIER (1)	COMMENT
2.2	0.300	1.6 x 0.8 x 0.8	MDT1608CH2R2N	TOKO	Smallest size, 75mA max
2.2	0.170	1 .6 x 0.8 x 0.8	GLFR1608T2R2M	TDK	Smallest size, 150mA max
2.2	0.245	2.0 x 1.2 x 1.0	MDT2012CH2R2N	TOKO	Small size, high efficiency
2.2	0.23	2.0 x 1.2 x 1.0	MIPSZ2012 2R2	TDK	
2.2	0.225	2.0 x 1.6 x 1.0	74438343022	Wurth	

### **Table 9-7. Inductor Series (continued)**

INDUCTANCE (µH)	DCR (Ω)	DIMENSIONS (mm³)	INDUCTOR TYPE	SUPPLIER (1)	COMMENT
2.2	0.12	2.5 x 2.0 x 1.2	MIPSA2520 2R2	TDK	
2.2	0.145	3.3 x 3.3 x 1.4	LPS3314	Coicraft	

#### (1) See Third-party Products Disclaimer

The PWM allows the use of small ceramic capacitors. Ceramic capacitors with low ESR values have the lowest output voltage ripple and are recommended. The output capacitor requires either an X7R or X5R dielectric. At light load currents, the converter operates in Power Save Mode and the output voltage ripple is dependent on the output capacitor value and the PFM peak inductor current. Because the PWM converter has a pulsating input current, a low ESR input capacitor is required on PMID for the best voltage filtering to ensure proper function of the device and to minimize input voltage spikes. For most applications a 10- $\mu$ F capacitor value is sufficient. The PMID capacitor can be increased to 22  $\mu$ F for better input voltage filtering.

Table 9-8 shows the recommended input/output capacitors.

#### Table 9-8. Capacitors

CAPACITANCE (µF)	SIZE	CAPACITOR TYPE	SUPPLIER <sup>(1)</sup>	COMMENT
10	0603	GRM188R60J106ME84	Murata	Recommended
10	0402	CL05A106MP5NUNC	Samsung EMA	Smallest size

#### (1) See Third-party Products Disclaimer

#### 9.3.21 Load Switch / LDO Output and Control

The device integrates a low Iq load switch which can also be used as a regulated output. The LSCTRL pin can be used to turn the load on or off. Activating LSCTRL continuously holds the switch in the on state so long as there is not a fault. The signal is active HI and has a low threshold making it capable of interfacing with low voltage signals. To limit voltage drop or voltage transients, a small ceramic capacitor must be placed close to VINLS. Due to the body diode of the PMOS switch, it is recommended to have the capacitor on VINLS ten times larger than the output capacitor on LS/LDO.

The output voltage is programmable using the LS\_LDO bits in the register. The LS/LDO voltage is calculated using Equation 9.

$$LS/LDO = 0.8 V + LS LDOCODE x 100 mV$$
(9)

If a value greater than 3.3 V is written, the setting goes to pass-through mode where LS/LDO = VINLS -  $V_{(DROPOUT)}$ . Table 9-9 summarizes the control of the LS/LDO output based on the I<sup>2</sup>C or LSCTRL pin setting:

Table 9-9. LS/LDO Output Control

I <sup>2</sup> C LS_LDO_EN	PIN LSCTRL	I <sup>2</sup> C V <sub>LDO</sub> > 3.3	LS/LDO OUTPUT	
0	0	0	Pulldown	
0	0	1	Pulldown	
0	1	0	$V_{LDO}$	
0	1	1	LSW	
1	0	0	$V_{LDO}$	
1	0	1	LSW	
1	1	0	$V_{LDO}$	
1	1	1 1		

If the output of the LDO is less than the programmed  $V_{(SYS)}$  voltage, connect VINLS to SYS. If the output of the LDO is greater than the programmed  $V_{SYS}$  voltage, connect VINLS to PMID.



The current capability of the LDO depends on the VINLS input voltage and the programmed output voltage. The full 100-mA output current for 0.8-V output voltage can be achieved when  $V_{(VINLS)} > 3.25$  V. The full 100-mA output current for 3.3-V output voltage can be achieved when  $V_{(VINLS)} > 3.6$  V.

When the LSLDO output is disabled with LSCTRL or through the register, an internal pull-down discharges the output.

#### 9.3.22 Manual Reset Timer and Reset Output (MR and RESET)

The  $\overline{\text{MR}}$  input has an internal pull-up to BAT, and  $\overline{\text{MR}}$  is functional only when BAT is present or when VIN is valid, stable, and charge is enabled. If  $\overline{\text{MR}}$  input is asserted during a transient condition while VIN ramps up the IC may incorrectly turn off the SYS buck output, therefore  $\overline{\text{MR}}$  should not be asserted during this condition in order to avoid unwanted shutdown of SYS output rail. The input conditions can be adjusted by using MRWAKE bits for the wake conditions and MRRESET bits for the reset conditions. When a wake condition is met, a 128-µs pulse is sent on INT to notify the host, and the WAKE1 and/or WAKE2 bits are updated on I<sup>2</sup>C. The MR\_WAKE bits and RESET FAULT bits are not cleared until the Push-button Control Register is read from I<sup>2</sup>C.

When a  $\overline{\text{MR}}$  reset condition is met, a 128-µs pulse is sent on INT to notify the host and a  $\overline{\text{RESET}}$  signal is asserted. A reset pulse occurs with duration of  $t_{\text{RESET}\_D}$  only one time after each valid MRRESET condition. The  $\overline{\text{MR}}$  pin must be released (go high) and then driven low for the MRWAKE period before  $\overline{\text{RESET}}$  asserts again. After  $\overline{\text{RESET}}$  is asserted with battery only present, the device enters either Ship mode or Hi-Z mode depending on MRREC register settings. For details on how to properly enter Ship Mode through MR, see Section 9.3.1.1 section. After  $\overline{\text{RESET}}$  is asserted with a valid  $V_{\text{IN}}$  present, the device resumes operation prior to the  $\overline{\text{MR}}$  button press. If SYS was disabled prior to  $\overline{\text{RESET}}$ , the SYS output is re-enabled if recovering into Hi-Z or Active Battery.

The MRRESET\_VIN register can be configured to have  $\overline{RESET}$  asserted by a button press only, or by a button press and  $V_{IN}$  present ( $V_{UVLO} + V_{SLP} < V_{IN} < V_{OVP}$ ).



## 9.4 Device Functional Modes

**Table 9-10. Modes and Functions** 

Table 3-10. Modes and I directions						
FUNCTION	READY (PRIOR TO I <sup>2</sup> C) AND AFTER RESET	HOST MODE READY (AFTER I <sup>2</sup> C)	CHARGE	SHIP MODE	HIGH_Z	ACTIVE BATTERY
VOVP	Yes	Yes	Yes	No	No	No
VUVLO	Yes	Yes	Yes	Yes	Yes	Yes
VBATUVLO	Yes	Yes	Yes	No	Yes	Yes
VINDPM	Default or registers	Default or registers	If enabled	No	No	No
SYS	Default or registers	Default or registers	If enabled	No	If enabled	If enabled
LS/LDO	Default or registers	Default or registers	If enabled	No	If enabled	If enabled
BATFET	Yes	Yes	Yes	No	Yes	Yes
TS	Yes (VIN Valid)	Yes (VIN Valid)	Yes	No	No	No
IPRETERM	External	Default, registers, or external	Default, registers, or external	No	No	No
ISET	External	Default, registers, or external	Default, registers, or external	No	No	No
ILIM	External	Default, registers, or external	Default, registers, or external	No	No	No
MR input	Yes	Yes	Yes	Yes	Yes	Yes
LSCTRL input	Yes	Yes	Yes	No	Yes	Yes
RESET output	Yes	Yes	Yes	No	Yes	Yes
INT output	Yes	Yes	Yes	No	No	Yes
I <sup>2</sup> C interface	Yes	Yes	Yes	No	No	Yes
CD input	Yes	Yes	Yes	No	Yes	Yes
PG output	Yes	Yes	Yes	No	No	If enabled
VBMON	No	Yes	No	No	No	Yes

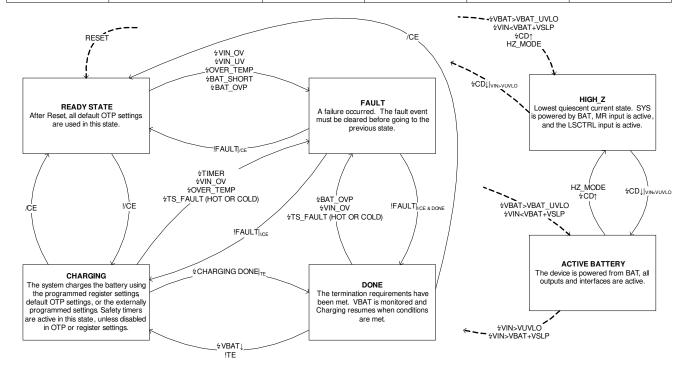
Table 9-11. Fault and Status Condition Responses

Table 3-11. I dait and otatus condition responses						
FAULT or STATUS	ACTIONS	CHARGER BEHAVIOR	SYS BEHAVIOR	LS/LDO BEHAVIOR	TS BEHAVIOR	
VIN_OV	Update VIN_OV status, Update STAT to fault, interrupt on INT, PG shown not good	Disabled	Enabled through BAT	Enabled through BAT	Disabled	
VIN_UV	Update VIN_UV status, interrupt on INT, PG shown not good	Disabled Enabled through BAT		Enabled through BAT	Disabled	
VIN_ILIM	Update charge in progress status, interrupt on INT, input current is limited	Enabled, input current limited Enabled (if enabled)		Enabled (if enabled)	Enabled	
OVER_TEMP		Disabled	Disabled	Disabled	Disabled	
BAT_UVLO	Update BAT_UVLO status, Update STAT to fault, interrupt on INT	Pre-charge	Enabled (if enabled) and VIN Valid	Enabled (if enabled) and VIN Valid	Enabled if VIN Valid	
SW_SYS_SHORT		Enabled	Current Limit	Enabled (if enabled)	Enabled	
LS_LDO_OCP		Enabled	Enabled (if enabled)	Current Limit	Enabled	
TIMER fault	Update TIMER, Update STAT to fault, interrupt on INT	Disabled	Enabled (if enabled)	Enabled (if enabled)	Disabled	
VINDPM	Update VINDPM_STAT, Update STAT to fault, interrupt on INT	Enabled, input current reduced	Enabled (if enabled)	Enabled (if enabled)	Enabled	



Table 9-11. Fault and Status Condition Responses (continued)

FAULT or STATUS	ACTIONS	CHARGER BEHAVIOR	SYS BEHAVIOR	LS/LDO BEHAVIOR	TS BEHAVIOR
TS_FAULT COLD or HOT	Update TS_FAULT to COLD OR HOT, Update STAT to fault, interrupt on INT	Disabled	Enabled (if enabled)	Enabled (if enabled)	Enabled
TS_FAULT COOL	Update TS_FAULT to COOL, Update STAT to fault, interrupt on INT	Reduce ICHG to ½	Enabled (if enabled)	Enabled (if enabled)	Enabled
TS_FAULT WARM	Update TS_FAULT to WARM, Update STAT to fault, interrupt on INT	Reduce VBATREG by 140 mV	Enabled (if enabled)	Enabled (if enabled)	Enabled
Charge Done	Update STAT to Charge Done, interrupt on INT	Disabled, monitor for VBAT falling below VRCHG	Enabled (if enabled)	Enabled (if enabled)	Enabled



#### Comments about naming convention

"/CE" or "HZ\_MODE" -> Register name: event caused by user / configuration

Figure 9-5. State Diagram

<sup>&</sup>quot;I" -> Not

<sup>&</sup>quot; $\rlap/v$ " -> Event caused by external influence

<sup>&</sup>quot;Event|  $_{\text{condition}}$ " -> describes the event with a specific condition

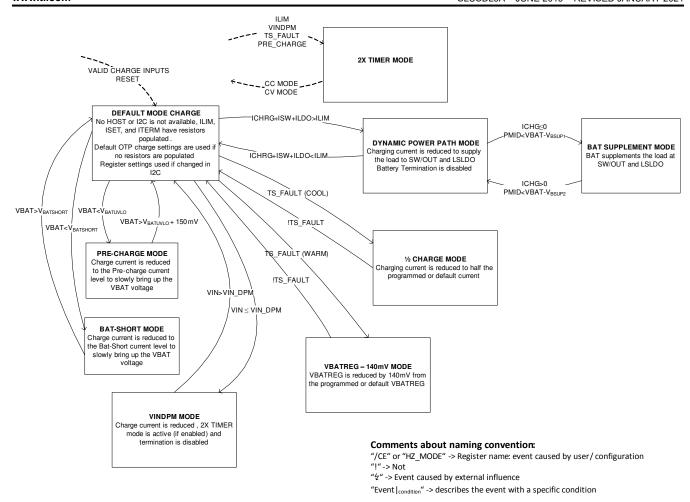


Figure 9-6. Change State Diagram

### 9.5 Programming

#### 9.5.1 Serial Interface Description

The device uses an I<sup>2</sup>C compatible interface to program and read many parameters. I<sup>2</sup>C is a 2-wire serial interface developed by NXP. The bus consists of a data line (SDA) and a clock line (SCL) with pull-up structures. When the bus is idle, both SDA and SCL lines are pulled high. All the I<sup>2</sup>C compatible devices connect to the I<sup>2</sup>C bus through open drain I/O terminals, SDA and SCL. A master device, usually a microcontroller or digital signal processor, controls the bus. The master is responsible for generating the SCL signal and device addresses. The master also generates specific conditions that indicate the START and STOP of data transfer. A slave device receives and/or transmits data on the bus under control of the master device.

The device works as a slave and supports the following data transfer modes, as defined in the  $I^2C$  BUS Specification: standard mode (100 kbps) and fast mode (400kbps). The interface adds flexibility to the battery management solution, enabling most functions to be programmed to new values depending on the instantaneous application requirements. The  $I^2C$  circuitry is powered from the battery in active battery mode. The battery voltage must stay above  $V_{(BATUVLO)}$  when no  $V_{IN}$  is present to maintain proper operation. The host must also wait for SYS to come up before starting communication with the part.

The data transfer protocol for standard and fast modes is exactly the same; therefore, they are referred to as the F/S-mode in this document. The device only supports 7-bit addressing. The device 7-bit address is 6A (8-bit shifted address is D4).



To avoid  $I^2C$  hang-ups, a timer ( $t_{I2CRESET}$ ) runs during  $I^2C$  transactions. If the SDA line is held low longer than  $t_{I2CRESET}$ , any additional commands are ignored and the  $I^2C$  engine is reset. The timeout is reset with START and repeated START conditions and stops when a valid STOP condition is sent.

#### 9.5.2 F/S Mode Protocol

The master initiates data transfer by generating a start condition. The start condition is when a high-to-low transition occurs on the SDA line while SCL is high, as shown in Figure 9-7. All I<sup>2</sup>C-compatible devices should recognize a start condition.

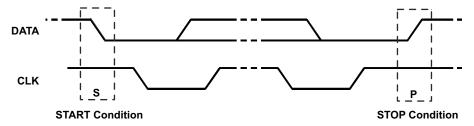


Figure 9-7. Start Stop Condition

The master then generates the SCL pulses, and transmits the address and the read/write direction bit R/W on the SDA line. During all transmissions, the master ensures that data is valid. A valid data condition requires the SDA line to be stable during the entire high period of the clock pulse (see Figure 9-8). All devices recognize the address sent by the master and compare it to their internal fixed addresses. Only the slave device with a matching address generates and acknowledge (see Figure 9-9) by pulling the SDA line low during the entire high period of the ninth SCL cycle. Upon detecting the acknowledge, the master knows that communication link with a slave has been established.

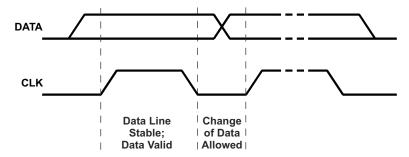


Figure 9-8. Bit Transfer on the Serial Interface

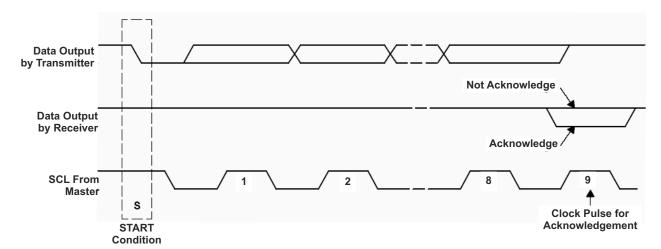


Figure 9-9. Acknowledge on the I<sup>2</sup>C Bus

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The master generates further SCL cycles to either transmit data to the slave (R/W bit 0) or receive data from the slave (R/W bit 1). In either case, the receiver needs to acknowledge the data sent by the transmitter. An acknowledge signal can either be generated by the master or by the slave, depending on which on is the receiver. The 9-bit valid data sequences consisting of 8-bit data and 1-bit acknowledge can continue as long as necessary. To signal the end of the data transfer, the master generates a stop condition by pulling the SDA line from low to high while the SCL line is high (see Figure 9-10). This releases the bus and stops the communication link with the addressed slave. All I<sup>2</sup>C compatible devices must recognize the STOP condition. Upon the receipt of a STOP condition, all devices know that the bus is released, and wait for a START condition followed by a matching address. If a transaction is terminated prematurely, the master needs to send a STOP condition to prevent the slave I<sup>2</sup>C logic from remaining in an incorrect state. Attempting to read data from register addresses not listed in this section results in 0xFFh being read out.

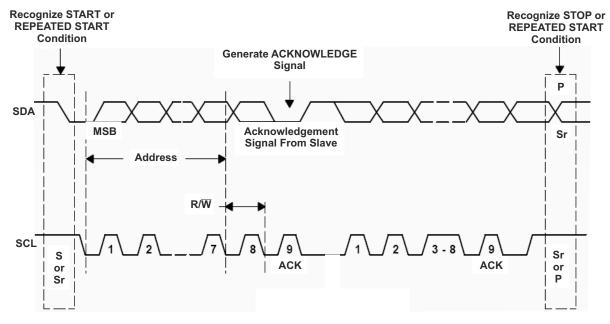


Figure 9-10. Bus Protocol



## 9.6 Register Maps

# 9.6.1 Status and Ship Mode Control Register

Memory location 0x00h, Reset State: xx0x xxx1 (BQ25125)

Figure 9-11. Status and Ship Mode Control Register

		1 19 11 1 1 1 1 1					
7 (MSB)	6	5	4	3	2	1	0 (LSB)
x	x	0	x	x	x	x	1
R	R	Write Only	R	R	R	R	R

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 9-12. Status and Ship Mode Control Register

Tubic of 12. Status and the state of the sta					
Bit	Field	Туре	Reset	Description	
B7 (MSB)	STAT_1	R	x	00 - Ready	
В6	STAT_0	R	x	01 - Charge in Progress 10 - Charge done 11 - Fault Status is current status only.	
B5	EN_SHIPMODE	Write Only	0	0 – Normal Operation 1 – Ship Mode Enabled	
B4	RESET_FAULT	R	х	1 – RESET fault. Indicates when the device meets the RESET conditions, and is cleared after I <sup>2</sup> C read.	
В3	TIMER	R	х	1 – Safety timer fault. Continues to show fault after an $I^2C$ read unless the $\overline{CD}$ pin or power have been toggled.	
B2	VINDPM_STAT	R	х	0 – VIN_DPM is not active 1 – VIN_DPM is active	
B1	CD_STAT	R	х	0 – $\overline{\text{CD}}$ low, IC enabled 1 – $\overline{\text{CD}}$ high, IC disabled	
B0 (LSB)	SYS_EN_STAT	R	х	1 – SW enabled 0 – SW disabled	



## 9.6.2 Faults and Faults Mask Register

Memory location 0x01h, Reset State: xxxx 0000 (BQ25125)

## Figure 9-12. Faults and Faults Mask Register

7 (MSB)	6	5	4	3	2	1	0 (LSB)
x	x	x	x	0	0	0	0
R	R	R	R	R/W	R/W	R/W	R/W

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

## Table 9-13. Faults and Faults Mask Register

Bit	Field	Туре	Reset	Description	
B7 (MSB)	VIN_OV	R	х	1 - V <sub>IN</sub> overvoltage fault. VIN_OV continues to show fault after an I <sup>2</sup> C read as long as OV exists	
В6	VIN_UV	R 1 - V <sub>IN</sub> undervoltage fault. VIN_UV is set when the input falls below V <sub>(UVLO)</sub> - V <sub>UVLO(HYS)</sub> . VIN_UV fault shows only one time Once read, VIN_UV clears until another UVLO event occurs.			
B5	BAT_UVLO			1 – BAT_UVLO fault. BAT_UVLO continues to show fault after an I <sup>2</sup> C read as long as BAT_UVLO conditions exist.	
B4	BAT_OCP	R	х	1 – BAT_OCP fault. BAT_OCP is cleared after I <sup>2</sup> C read.	
В3	VIN_OV_M	R/W	0	1 – Mask V <sub>IN</sub> overvoltage fault	
B2	VIN_UV_M	R/W	0	1 – Mask V <sub>IN</sub> undervoltage fault	
B1	BAT_UVLO_M	R/W	0	1 – Mask BAT UVLO fault	
B0 (LSB)	BAT_OCP_M	R/W	0	1 – Mask BAT_OCP fault	
If a fault is r	ead on the status register and it is neit	her of any	of the faults in	n this register or subsequent registers, it indicates an ILIM fault.	



### 9.6.3 TS Control and Faults Masks Register

Memory location 0x02h, Reset State: 1xxx 1000 (BQ25125)

Figure 9-13. TS Control and Faults Masks Register (02)

		J				,	
7 (MSB)	6	5	4	3	2	1	0 (LSB)
1	x	x	x	1	0	0	0
R/W	R	R	R	R/W	R/W	R/W	R/W

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

## Table 9-14. TS Control and Faults Masks Register, Memory Location 0010

Bit	Field	Туре	Reset	Description
B7 (MSB)	TS_EN	R/W	1	0 – TS function disabled 1 – TS function enabled
B6	TS_FAULT1	R	х	TS Fault mode:
B5	TS_FAULT0	10 – T <sub>COOL</sub> > TS temp > T <sub>COLD</sub> (Charging current rechalf)		$ \begin{array}{l} 01-\text{TS temp} < T_{COLD} \text{ or TS temp} > T_{HOT} \text{ (Charging suspended)} \\ 10-T_{COOL} > \text{TS temp} > T_{COLD} \text{ (Charging current reduced by half)} \\ 11-T_{WARM} < \text{TS temp} < T_{HOT} \text{ (Charging voltage reduced by} \\ \end{array} $
B4	Reserved	R	х	Reserved
В3	EN_INT	R/W	1	0 – Disable INT function (INT only shows faults and does not show charge status) 1 – Enable INT function (INT shows faults and charge status)
B2	WAKE_M	R/W	0	1 – Mask interrupt from Wake Condition from MR
B1	RESET_M	R/W	0	$1-\text{Mask}$ RESET interrupt from $\overline{\text{MR}}$ . The RESET output is not masked by this bit.
B0 (LSB)	TIMER_M	R/W	0	1 – Mask Timer fault interrupt (safety)

To save power, the device will shut off the clock that counts the deglitch time for the faults in the Hi-Z mode. For any of the fault conditions that contain a deglitch time as specified in the Section 8.5, the device will have to be in Active BAT with an I<sup>2</sup>C transaction or VIN present to count against the deglitch to clear the fault on the register.

Product Folder Links: BQ25125



### 9.6.4 Fast Charge Control Register

Memory location 0x03h, Reset State: 0001 0100 (BQ25125)

#### Figure 9-14. Fast Charge Control Register

7 (MSB)	6	5	4	3	2	1	0 (LSB)
0	0	0	1	0	1	0	0
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

### **Table 9-15. Fast Charge Control Register**

Bit	Field	Туре	Reset	Description
B7 (MSB)	ICHRG_RANGE	1-mA steps		1 – to select charge range from 40 mA to 300 mA, ICHRG bits
В6	ICHRG_4	R/W	0	Charge current 16 mA or 160 mA
B5	ICHRG_3	R/W	0	Charge current 8 mA or 80 mA
B4	ICHRG_2	R/W	1	Charge current 4 mA or 40 mA
В3	ICHRG_1	R/W	0	Charge current 2 mA or 20 mA
B2	ICHRG_0	R/W	1	Charge current 1 mA or 10 mA
B1	CE	R/W	0	0 – Charger enabled 1 – Charger is disabled
B0 (LSB)	HZ_MODE	R/W	0	0 – Not high impedance mode 1 – High impedance mode

ICHRG\_RANGE and ICHRG bits are used to set the charge current. The  $I_{CHRG}$  is calculated using the following equation: If ICHRG\_RANGE is 0, then  $I_{CHRG}$  = 5 mA +  $I_{CHRG}$ CODE x 1 mA. If ICHRG\_RANGE is 1, then  $I_{CHRG}$  = 40 mA +  $I_{CHRG}$ CODE x 10 mA. If a value greater than 35 mA (ICHRG\_RANGE = 0) or 300 mA (ICHRG\_RANGE = 1) is written, the setting goes to 35 mA or 300 mA respectively except if the ICHRG bits are all 1 (that is, 11111), then the externally programmed value is used. The PRETERM bits must also be set prior to writing all 1s to ensure the external ISET current is used as well as the proper termination and pre-charge values are used. For IPRETERM = 5%, set the IPRETERM bits to 000010, for IPRETERM = 10%, set the IPRETERM bits to 000100, and for IPRETERM = 20%, set the iPRETERM bits to 001000. The default may be overridden by the external resistor on ISET.

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### 9.6.5 Termination/Pre-Charge Register

Memory location 0x04h, Reset State: 0000 1110 (BQ25125)

### Figure 9-15. Termination/Pre-Charge Register

7 (MSB)	6	5	4	3	2	1	0 (LSB)
0	0	0	0	1	1	1	0
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

## Table 9-16. Termination/Pre-Charge Register

Bit	Field	Туре	Reset	Description
B7 (MSB)	IPRETERM_RANGE	IF 1		0 – to select termination range from 500 μA to 5 mA, IPRETERM bits are 500-μA steps 1 – to select charge range from 6 mA to 37 mA, IPRETERM bits are 1-mA steps
В6	IPRETERM_4	R/W	0	Termination current 8 mA or 16 mA
B5	IPRETERM_3	R/W	0	Termination current 4 mA or 8 mA
B4	IPRETERM_2	R/W	0	Termination current 2 mA or 4 mA
В3	IPRETERM_1	R/W	1	Termination current 1 mA or 2 mA
B2	IPRETERM_0	R/W	1	Termination current 500 µA or 1 mA
B1	TE	R/W	1	0 – Disable charge current termination 1 – Enable charge current termination
B0 (LSB)		R/W	0	

IPRETERM\_RANGE and IPRETERM bits are used to set the termination and pre-charge current. The I<sub>TERM</sub> is calculated using the following equation: If IPRETERM\_RANGE is 0, then I<sub>TERM</sub> =  $500 \,\mu\text{A} + I_{\text{TERM}}\text{CODE} \times 500 \,\mu\text{A}$ . If IPRETERM\_RANGE is 1, then I<sub>TERM</sub> =  $6 \,\text{mA} + I_{\text{TERM}}\text{CODE} \times 1 \,\text{mA}$ . If a value greater than 5 mA (IPRETERM\_RANGE = 0) is written, the setting goes to 5 mA. Termination is disabled if any loop other than CC or DV in control, such as VINDPM, and TS/Cool. The default may be overridden by the external resistor on IPRETERM.

#### 9.6.6 Battery Voltage Control Register

Memory location 0x05h, Reset State: 0111 1000 (BQ25125)

#### Figure 9-16. Battery Voltage Control Register

7 (MSB)	6	5	4	3	2	1	0 (LSB)
0	1	1	1	1	0	0	0
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

## Table 9-17. Battery Voltage Control Register

Bit	Field	Туре	Reset	Description
B7 (MSB)	VBREG_6	R/W	0	Battery Regulation Voltage: 640 mV
В6	VBREG_5	R/W	1	Battery Regulation Voltage: 320 mV
B5	VBREG_4	R/W	1	Battery Regulation Voltage: 160 mV
B4	VBREG_3	R/W	1	Battery Regulation Voltage: 80 mV
В3	VBREG_2	R/W	1	Battery Regulation Voltage: 40 mV
B2	VBREG_1	R/W	0	Battery Regulation Voltage: 20 mV
B1	VBREG_0	R/W	0	Battery Regulation Voltage: 10 mV
B0 (LSB)		R/W	0	

Product Folder Links: BQ25125



Table 9-17. Battery Voltage Control Register (continued)

VBREG Bits: Use VBREG bits to set the battery regulation threshold. The  $V_{BATREG}$  is calculated using the following equation:  $V_{BATREG} = 3.6$  V +  $V_{BREG}$ CODE x 10 mV. The charge voltage range is from 3.6 V to 4.65 V. If a value greater than 4.65 V is written, the setting goes to 4.65 V.

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### 9.6.7 SYS VOUT Control Register

Memory location 0x06h, Reset State: 1010 1010 (BQ25125)

### Figure 9-17. SYS VOUT Control Register

7 (MSB)	6	5	4	3	2	1	0 (LSB)
1	0	1	0	1	0	1	0
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

## Table 9-18. SYS VOUT Control Register

Bit	Field	Туре	Reset	Description
B7 (MSB)	EN_SYS_OUT	R/W	1	0 – Disable SW 1 – Enable SW (When disabled, output is pulled low)
В6	SYS_SEL1	R/W	0	00 – 1.1 V and 1.2 V selection
B5	SYS_SEL0	R/W	1	01 – 1.3 V through 2.8 V selection 10 – 1.5V through 2.75 V selection 11 – 1.8 V through 3.3 V selection
B4	SYS_VOUT_3	R/W	0	OUT Voltage: 800 mV step if SYS_SEL is 01 or 11
В3	SYS_VOUT_2	R/W	1	OUT Voltage: 400 mV step if SYS_SEL is 01 or 11
B2	SYS_VOUT_1	R/W	0	OUT Voltage: 200 mV step if SYS_SEL is 01 or 11
B1	SYS_VOUT_0	R/W	1	OUT Voltage: 100 mV step if SYS_SEL is 01 or 11
B0 (LSB)			0	

SW\_VOUT Bits: Use SYS\_SEL and SYS\_VOUT bits to set the output on SYS. The SYS voltage is calculated using the following equation: See table below for all VOUT values that can be programmed through SYS\_SEL and SYS\_VOUT.

If SYS\_SEL = 01, then SYS = 1.30 V + SYS\_VOUTCODE x 100 mV.

If SYS\_SEL = 11, then SYS = 1.80 V + SYS\_VOUTCODE x 100 mV.

Table 9-19. SYS\_SEL Codes

SYS_SEL	SYS_VOUT	TYP	UNIT
00	0000	1.1	V
00	0001	1.2	V
00	0010	1.25	V
00	0011	1.333	V
00	0100	1.417	V
00	0101	1.5	V
00	0110	1.583	V
00	0111	1.667	V
00	1000	1.75	V
00	1001	1.833	V
00	1010	1.917	V
00	1011	2	V
00	1100	2.083	V
00	1101	2.167	V
00	1110	2.25	V
00	1111	2.333	V
01	0000	1.3	V
01	0001	1.4	V
01	0010	1.5	V
01	0011	1.6	V

Product Folder Links: BQ25125



Table 9-19. SYS SEL Codes (continued)

SYS_SEL         SYS_VOUT         TYP         UN           01         0100         1.7         V           01         0101         1.8         V           01         0110         1.9         V           01         0111         2         V           01         1000         2.1         V           01         1001         2.2         V           01         1010         2.3         V           01         1011         2.4         V           01         1100         2.5         V           01         1101         2.6         V           01         1110         2.7         V           01         1111         2.8         V           01         1111         2.8         V           10         0000         1.5         V           10         0010         1.583         V           10         0010         1.833         V           10         0101         1.917         V           10         0101         1.917         V           10         0110         2         V	,
01         0101         1.8         V           01         0110         1.9         V           01         0111         2         V           01         1000         2.1         V           01         1001         2.2         V           01         1010         2.3         V           01         1011         2.4         V           01         1100         2.5         V           01         1101         2.6         V           01         1110         2.7         V           01         1111         2.8         V           01         1111         2.8         V           10         0000         1.5         V           10         0001         1.583         V           10         0010         1.833         V           10         0101         1.917         V           10         0101         1.917         V           10         0110         2         V	
01         0110         1.9         V           01         0111         2         V           01         1000         2.1         V           01         1001         2.2         V           01         1010         2.3         V           01         1011         2.4         V           01         1100         2.5         V           01         1101         2.6         V           01         1110         2.7         V           01         1111         2.8         V           10         0000         1.5         V           10         0001         1.583         V           10         0010         1.833         V           10         0101         1.917         V           10         0101         1.917         V           10         0110         2         V	
01         0111         2         V           01         1000         2.1         V           01         1001         2.2         V           01         1010         2.3         V           01         1011         2.4         V           01         1100         2.5         V           01         1101         2.6         V           01         1110         2.7         V           01         1111         2.8         V           01         1111         2.8         V           10         0000         1.583         V           10         0010         1.667         V           10         0010         1.833         V           10         0101         1.917         V           10         0110         2         V	•
01       1000       2.1       V         01       1001       2.2       V         01       1010       2.3       V         01       1011       2.4       V         01       1100       2.5       V         01       1101       2.6       V         01       1110       2.7       V         01       1111       2.8       V         10       0000       1.5       V         10       0001       1.583       V         10       0010       1.667       V         10       0100       1.833       V         10       0101       1.917       V         10       0110       2       V	,
01       1001       2.2       V         01       1010       2.3       V         01       1011       2.4       V         01       1100       2.5       V         01       1101       2.6       V         01       1110       2.7       V         01       1111       2.8       V         10       0000       1.5       V         10       0001       1.583       V         10       0010       1.667       V         10       0010       1.833       V         10       0101       1.917       V         10       0110       2       V	'
01       1010       2.3       V         01       1011       2.4       V         01       1100       2.5       V         01       1101       2.6       V         01       1110       2.7       V         01       1111       2.8       V         10       0000       1.5       V         10       0001       1.583       V         10       0010       1.667       V         10       0010       1.833       V         10       0101       1.917       V         10       0110       2       V	1
01     1011     2.4     V       01     1100     2.5     V       01     1101     2.6     V       01     1110     2.7     V       01     1111     2.8     V       10     0000     1.5     V       10     0001     1.583     V       10     0010     1.667     V       10     0011     1.75     V       10     0100     1.833     V       10     0101     1.917     V       10     0110     2     V	'
01     1100     2.5     V       01     1101     2.6     V       01     1110     2.7     V       01     1111     2.8     V       10     0000     1.5     V       10     0001     1.583     V       10     0010     1.667     V       10     0011     1.75     V       10     0100     1.833     V       10     0101     1.917     V       10     0110     2     V	,
01     1101     2.6     V       01     1110     2.7     V       01     1111     2.8     V       10     0000     1.5     V       10     0001     1.583     V       10     0010     1.667     V       10     0011     1.75     V       10     0100     1.833     V       10     0101     1.917     V       10     0110     2     V	'
01     1110     2.7     V       01     1111     2.8     V       10     0000     1.5     V       10     0001     1.583     V       10     0010     1.667     V       10     0011     1.75     V       10     0100     1.833     V       10     0101     1.917     V       10     0110     2     V	'
01     1111     2.8     V       10     0000     1.5     V       10     0001     1.583     V       10     0010     1.667     V       10     0011     1.75     V       10     0100     1.833     V       10     0101     1.917     V       10     0110     2     V	'
10     0000     1.5     V       10     0001     1.583     V       10     0010     1.667     V       10     0011     1.75     V       10     0100     1.833     V       10     0101     1.917     V       10     0110     2     V	'
10     0001     1.583     V       10     0010     1.667     V       10     0011     1.75     V       10     0100     1.833     V       10     0101     1.917     V       10     0110     2     V	,
10     0010     1.667     V       10     0011     1.75     V       10     0100     1.833     V       10     0101     1.917     V       10     0110     2     V	,
10     0011     1.75     V       10     0100     1.833     V       10     0101     1.917     V       10     0110     2     V	'
10     0100     1.833     V       10     0101     1.917     V       10     0110     2     V	1
10 0101 1.917 V 10 0110 2 V	,
10 0110 2 V	,
	1
10 0444 0.000	,
10 0111 2.083 V	1
10 1000 2.167 V	1
10 1001 2.25 V	,
10 1010 2.333 V	,
10 1011 2.417 V	,
10 1100 2.5 V	,
10 1101 2.583 V	1
10 1110 2.667 V	'
10 1111 2.75 V	1
11 0000 1.8 V	1
11 0001 1.9 V	1
11 0010 2 V	,
11 0011 2.1 V	,
11 0100 2.2 V	1
11 0101 2.3 V	1
11 0110 2.4 V	1
11 0111 2.5 V	,
11 1000 2.6 V	,
11 1001 2.7 V	,
11 1010 2.8 V	,
11 1011 2.9 V	'
11 1100 3 V	,
11 1101 3.1 V	,
11 1110 3.2 V	,
11 1111 3.3 V	,



### 9.6.8 Load Switch and LDO Control Register

Memory location 0x07h, Reset State: 0010 1000 (BQ25125)

### Figure 9-18. Load Switch and LDO Control Register

		•					
7 (MSB)	6	5	4	3	2	1	0 (LSB)
0	0	1	0	1	0	0	0
R/W	R/W	R/W	R/W	R/W	R/W	R	R

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

### Table 9-20. Load Switch and LDO Control Register

Bit	Field	Туре	Reset	Description
B7 (MSB)	EN_LS_LDO	R/W	0	0 – Disable LS/LDO 1 – Enable LS/LDO
В6	LS_LDO_4	R/W	0	LS/LDO Voltage: 1600 mV
B5	LS_LDO_3	R/W	1	LS/LDO Voltage: 800 mV
B4	LS_LDO_2	R/W	0	LS/LDO Voltage: 400 mV
В3	LS_LDO_1	R/W	1	LS/LDO Voltage: 200 mV
B2	LS_LDO_0	R/W	0	LS/LDO Voltage: 100 mV
B1			0	
B0 (LSB)	MRRESET_VIN	R/W	0	0 – Reset sent when $\overline{MR}$ Reset time is met 1 – Reset sent when $\overline{MR}$ Reset time is met and $V_{UVLO}$ + $V_{SLP}$ < $VIN$ < $V_{OVP}$

LS\_LDO Bits: Use LS\_LDO bits to set the LS/LDO output. The LS/LDO voltage is calculated using the following equation: LS/LDO = 0.8 V + LS = 100 mV. If a value greater than 3.3 V is written, the setting goes to pass-through mode where LS/LDO = VINLS -  $\text{V}_{\text{DROPOUT}}$ . The LS\_LDO output can only be changed when the EN\_LS\_LDO and LSCTRL pin has disabled the output.

Product Folder Links: BQ25125



## 9.6.9 Push-button Control Register

Memory location 0x08h, Reset State: 0110 10xx (BQ25125)

### Figure 9-19. Push-button Control Register

7 (MSB)	6 5		4 3		2 1		0 (LSB)
0	1	1	0	1	0	x	x
R/W	R/W	R/W	R/W	R/W	R/W	R	R

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

## Table 9-21. Push-button Control Register

Bit	Field	Туре	Reset	Description
B7 (MSB)	MRWAKE1	R/W	0	MR Timer adjustment for WAKE1: 0 − 80 ms < MR 1 − 600 ms < MR
В6	MRWAKE2	R/W	1	MR Timer adjustment for WAKE2: 0 −1000 ms < MR 1 − 1500 ms < MR
B5	MRREC	R/W	1	0 – After Reset, device enters Ship mode 1 – After Reset, device enters Hi-Z Mode
B4	MRRESET_1	R/W	0	MR Timer adjustment for reset:
В3	MRRESET_0	R/W	1	$00 - 5 s \pm 20\%$ $01 - 9 s \pm 20\%$ $10 - 11 s \pm 20\%$ $11 - 15 s \pm 20\%$
B2	PGB_MR	R/W	0	0 – Output functions as $\overline{PG}$ 1 – Output functions as voltage shifted push-button ( $\overline{MR}$ ) input
B1	WAKE1	R	х	1 – WAKE1 status. Indicates when the device meets the WAKE1 conditions, and is cleared after I <sup>2</sup> C read.
B0 (LSB)	WAKE2	R	x	1 – WAKE2 status. Indicates when the device meets the WAKE2 conditions, and is cleared after I <sup>2</sup> C read.



### 9.6.10 ILIM and Battery UVLO Control Register

Memory location 0x09h, Reset State: 0000 1010 (BQ25125)

#### Figure 9-20. ILIM and Battery UVLO Control Register

7 (MSB)	6	5	4	3	2	1	0 (LSB)
0	0	0	0	1	0	1	0
Write	R/W						

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

### Table 9-22. ILIM and Battery UVLO Control Register, Memory Location 1001

Bit	Field	Туре	Reset	Description
B7 (MSB)	RESET	Write only	0	Write: 1- Reset all registers to default values 0 – No effect Read: Always get 0
B6		R/W	0	N/A
B5	INLIM_2	R/W	0	Input Current Limit: 200 mA
B4	INLIM_1	R/W	0	Input Current Limit: 100 mA
В3	INLIM_0	R/W	1	Input Current Limit: 50 mA
B2	BUVLO_2	R/W	0	000, 001: RESERVED
B1	BUVLO_1	R/W	1	010: BUVLO = 3.0 V 011: BUVLO = 2.8 V
B0 (LSB)	BUVLO_0	R/W	0	100: BUVLO = 2.6 V 101: BULVO = 2.4 V 110: BUVLO = 2.2 V 111: BUVLO = 2.2V

INLIM Bits: Use INLIM bits to set the input current limit. The  $I_{(INLIM)}$  is calculated using the following equation:  $I_{(INLIM)} = 50 \text{ mA} + I_{(INLIM)} = 50 \text{ mA}$ . The default may be overridden by the external resistor on ILIM.

#### 9.6.11 Voltage Based Battery Monitor Register

Memory location 0x0Ah, Reset State: 0xxx xxxx (BQ25125)

#### Figure 9-21. Voltage Based Battery Monitor Register

7 (MSB)	6	5	4	3	2	1	0 (LSB)
0	x	x	x	x	x	x	х
R/W	R	R	R	R	R	R	R

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

### Table 9-23. Voltage Based Battery Monitor Register, Memory Location 1010

Bit	Field	Туре	Reset	Description
B7 (MSB)	VBMON_READ	R/W	0	Write 1 to initiate a new VBATREG reading. Read always 0.
В6	VBMON_RANGE_1	R	х	11 – 90% to 100% of VBATREG
B5	VBMON_RANGE_0	R	х	10 – 80% to 90% of VBATREG 01 – 70% to 80% of VBATREG 00 – 60% to 70% of VBATREG
B4	VBMON_TH_2	R	х	111 – Above 8% of VBMON_RANGE
В3	VBMON_TH_1	R	x	110 – Above 6% of VBMON_RANGE 011 – Above 4% of VBMON_RANGE
B2	VBMON_TH_0	R	х	010 – Above 2% of VBMON_RANGE 001 – Above 0% of VBMON_RANGE
B1		R	х	N/A
B0 (LSB)		R	х	N/A

Product Folder Links: BQ25125

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### Table 9-23. Voltage Based Battery Monitor Register, Memory Location 1010 (continued)

Bit	Field	Type	Reset	Description

The VBMON registers are used to determine the battery voltage. Before entering a low power state, the device will determine the voltage level by starting at VBMON\_RANGE 11 (90% to 100%), and if VBMON\_TH of 000 is read, then it will move to VBMON\_RANGE 10 (80% to 90%) and continue until a non 000 value of VBMON TH is found. If this does not happen, then VBMON RANGE and VBMON TH will be written with 00 000. The VBMON\_READ bit can be used to initiate a new reading by writing a 1 to it. Example: A reading of 10 011 indicated a VBAT voltage of between 84% and 86% of the VBATREG setting.

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## 9.6.12 VIN\_DPM and Timers Register

Memory location 0x0Bh, Reset State: 1100 0010 (BQ25125)

## Figure 9-22. VIN\_DPM and Timers Register

7 (MSB)	6	5	4	3	2	1	0 (LSB)	
1	1	0	0	0	0	1	0	
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W	

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

## Table 9-24. VIN\_DPM and Timers Register

Bit	Field	Туре	Reset	Description						
B7 (MSB)	VINDPM_ON	R/W	1	0 - enable VINDPM 1 - disable VINDPM						
В6	VINDPM_2	R/W	1	Input V <sub>(IN_DPM)</sub> voltage: 400 mV						
B5	VINDPM_1	R/W	0	Input V <sub>(IN_DPM)</sub> voltage: 200 mV						
B4	VINDPM_0	R/W	0	Input V <sub>(IN_DPM)</sub> voltage: 100 mV						
В3	2XTMR_EN	R/W	0	0 – Timer is not slowed at any time 1 – Timer is slowed by 2x when in any control other than CC or CV						
B2	TMR_1	R/W	0	Safety Timer Time Limit						
B1	TMR_0	R/W	1	00 – 30 minute fast charge 01 – 3 hour fast charge 10 – 9 hour fast charge 11 – Disable safety timers						
B0 (LSB)			0							
The VINDP	The VINDPM threshold is set using the following equation: VINDPM = 4.2 + VINDPM_CODE x 100 mV									

Product Folder Links: BQ25125

## 10 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

#### 10.1 Application Information

A typical design is shown in Figure 10-1. This design uses the BQ25125 with external resistors for ILIM, IPRETERM, and ISET. These are not needed if these values are set with a host controller through  $I^2C$  commands. This design also shows the TS resistors, which is also optional.

When powering up in default mode the battery voltage is the default for the part (4.2 V), the SYS output is the default (1.8 V). External resistors set the charge current to 40 mA, the termination current to 10% (4 mA), and the input current limit to 100 mA. If the I<sup>2</sup>C interface is used the part goes to the internal default settings until changed by the host.

### 10.2 Typical Application

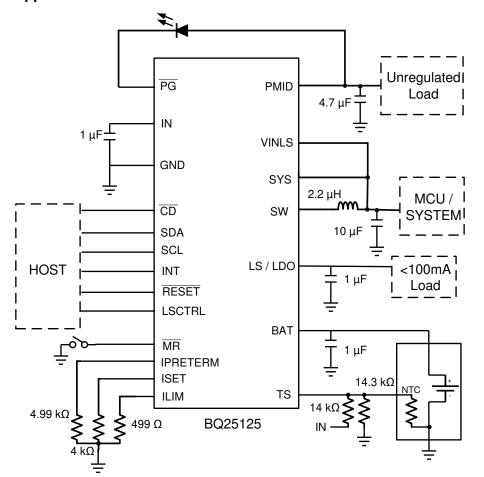


Figure 10-1. Typical Application Circuit



#### 10.2.1 Design Requirements

This application is for a low power system that has varying loads from less than 10 mA up to 300 mA. It must work with a valid adaptor or USB power input. Below are some of the key components that are needed in normal operation. For this example, the fast charge current is 50 mA, input current limit is 400 mA and the pre-charge and termination current is 10% of the fast charge current.

- Supply voltage = 3.4 V to 20 V
- Fast charge current is default to 10 mA with ISET pin shorted to ground. To program the fast charge current, connect an external resistor from ISET to ground.
- Input current limit is default to 100 mA with ILIM pin shorted to ground. To program the input current limit, connect an external resistor from ILIM to ground.
- Termination current threshold is default to 2 mA with IPRETERM pin shorted to ground. To program the input current limit, connect an external resistor from IPRETERM to ground.
- A 2.2-µH inductor is needed between SW pin and SYS pin for PWM output.
- TS- Battery temperature sense needs a NTC connected on TS pin.

#### 10.2.2 Detailed Design Procedure

See Figure 10-1 for an example of the application diagram.

#### 10.2.2.1 Default Settings

- Connect ISET, ILIM and IPRETERM pins to ground to program fast charge current to 10 mA, input current limit to 100 mA and pre-charge/termination current to 2 mA.
- BAT UVLO = 3 V.
- VSYS = 1.8 V
- · LS/LDO is LS
- VBREG = 4.2 V
- VIN DPM is enabled and VIN DPM Threshold = 4.6 V.
- Safety Timer = 3 hr
- If the function is not needed, connect TS to the center tab of the resistor divider between V<sub>IN</sub> and the ground.
   (pull up resistor = 14 kΩ, pull down resistor = 14.3 kΩ)

#### 10.2.2.2 Choose the Correct Inductance and Capacitance

Refer to the Section 9.3.20 section for the detailed procedure to determine the optimal inductance and capacitance for the buck output.

#### 10.2.2.3 Calculations

#### 10.2.2.3.1 Program the Fast Charge Current (ISET)

$$R_{ISET} = K_{ISET}/ICHG$$
 (10)

 $K_{ISET}$  = 200 A $\Omega$  from the Section 8 table

$$R_{ISFT} = 200 A\Omega / 0.05 A = 4 k\Omega$$
 (11)

Select the closest standard value, which in this case is 4.99 k $\Omega$ . Connect this resistor between ISET pin and GND.

#### 10.2.2.3.2 Program the Input Current Limit (ILIM)

$$R_{\text{ILIM}} = K_{\text{ILIM}} / I_{\text{I MAX}} \tag{12}$$

 $K_{ILIM}$  = 200 A $\Omega$  from the Section 8 table

$$R_{IIM} = 200 A\Omega / 0.4 A = 500 \Omega$$
 (13)

Select the closest standard value, which in this case is 499  $\Omega$ . Connect this resistor between ILIM pin and GND.

### 10.2.2.3.3 Program the Pre-charge/termination Threshold (IPRETERM)

According to Table 9-3, the RIPRETERM is 4990  $\Omega$  for 10% termination threshold. Therefore, connect a 4.99-k $\Omega$  resistor between IPRETERM pin and GND.

#### 10.2.2.3.4 TS Resistors (TS)

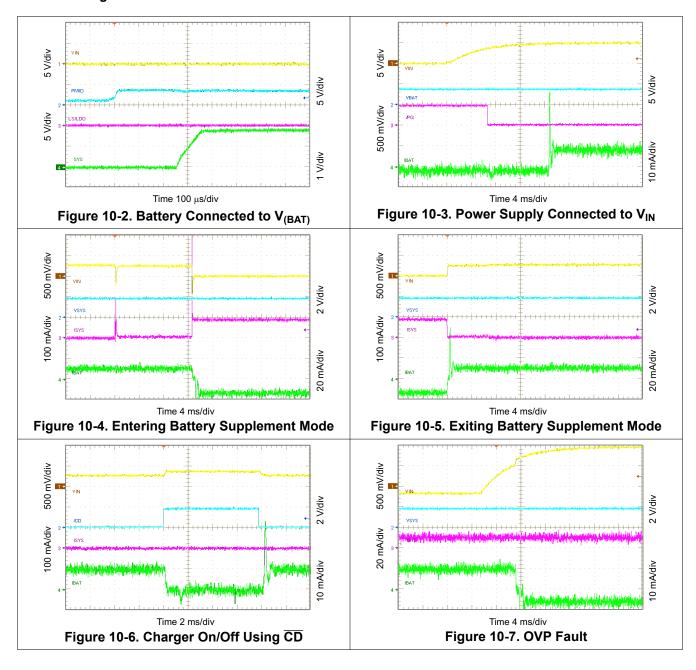
The voltage at TS is monitored to determine that the battery is at a safe temperature during charging. This device uses JEITA temperature profile which has four temperature thresholds. Refer to Section 8 for the detailed thresholds number.

The TS circuit is shown in Figure 9-4. The resistor values can be calculated using Equation 1 and Equation 2.

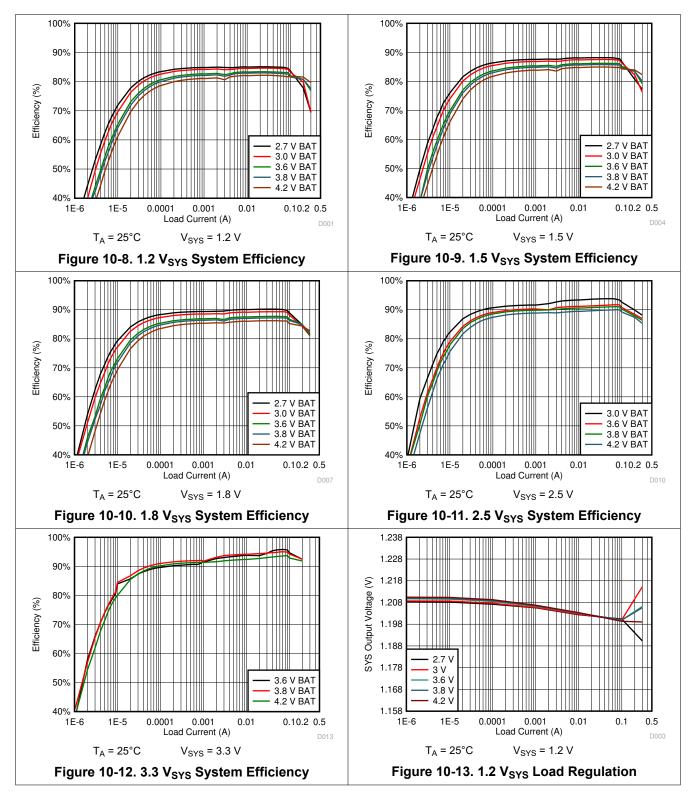


### 10.2.3 Application Performance Curves

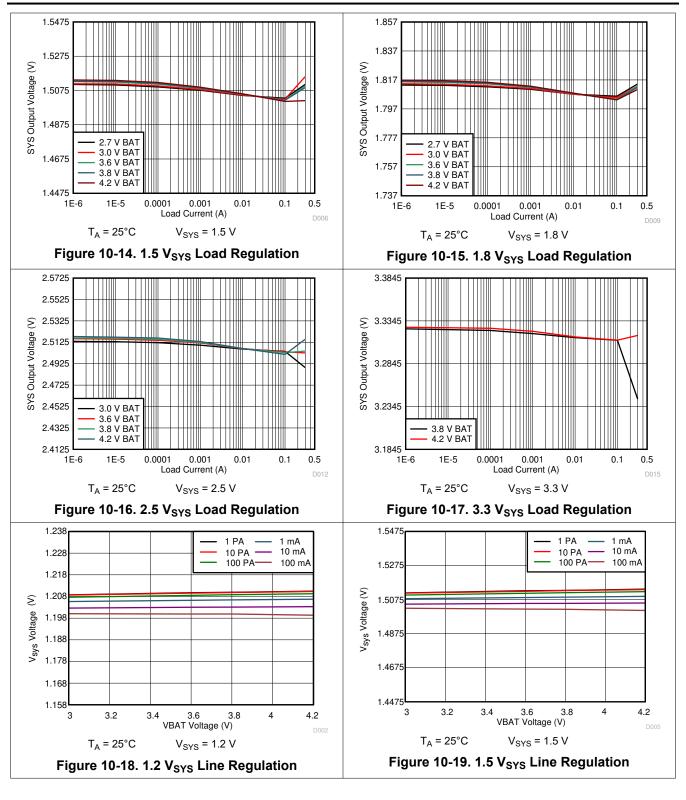
## 10.2.3.1 Charger Curves

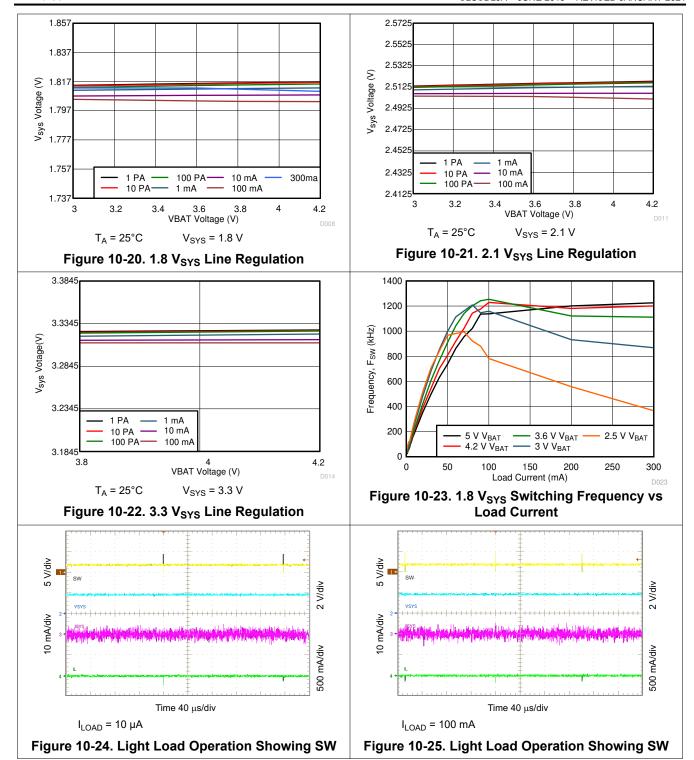


### 10.2.3.2 SYS Output Curves

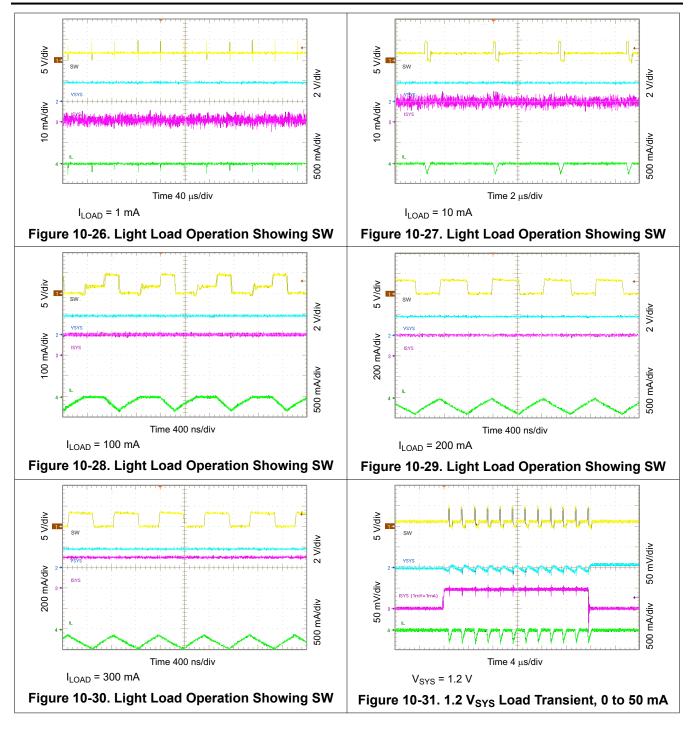


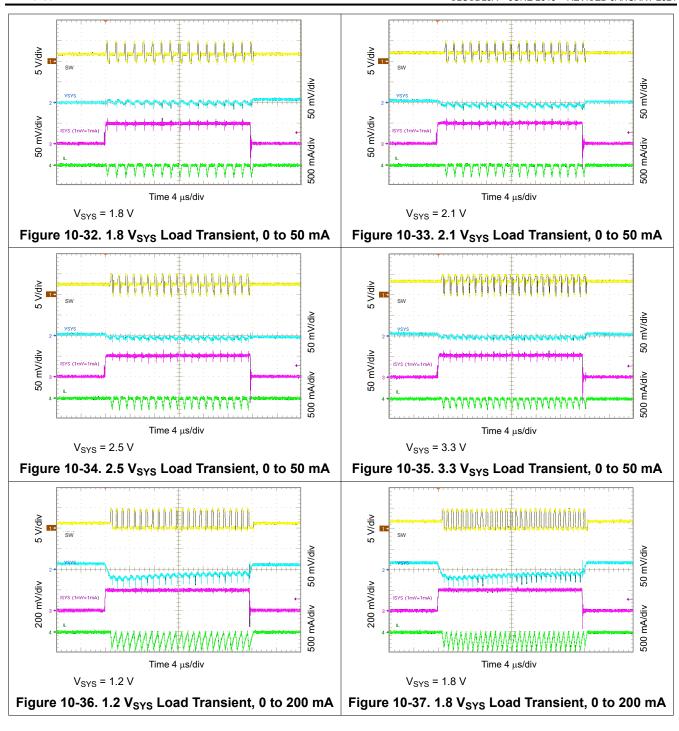




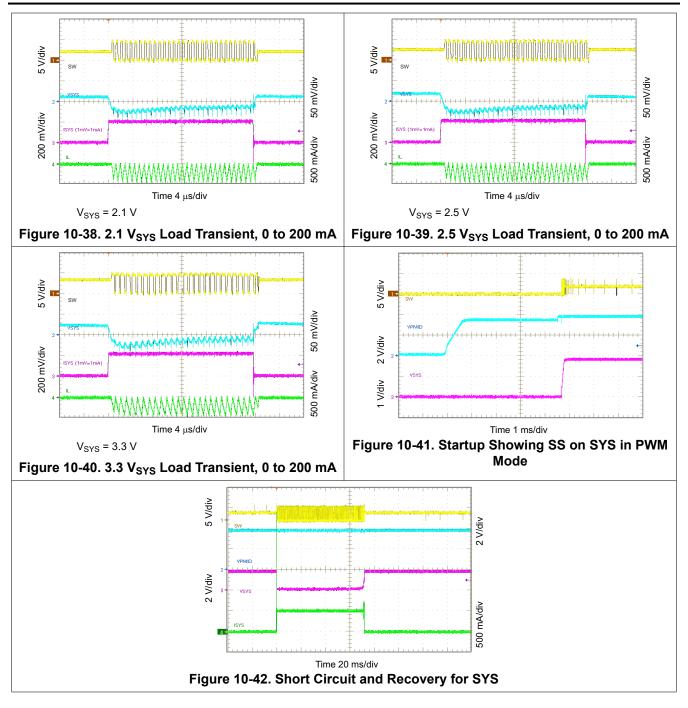




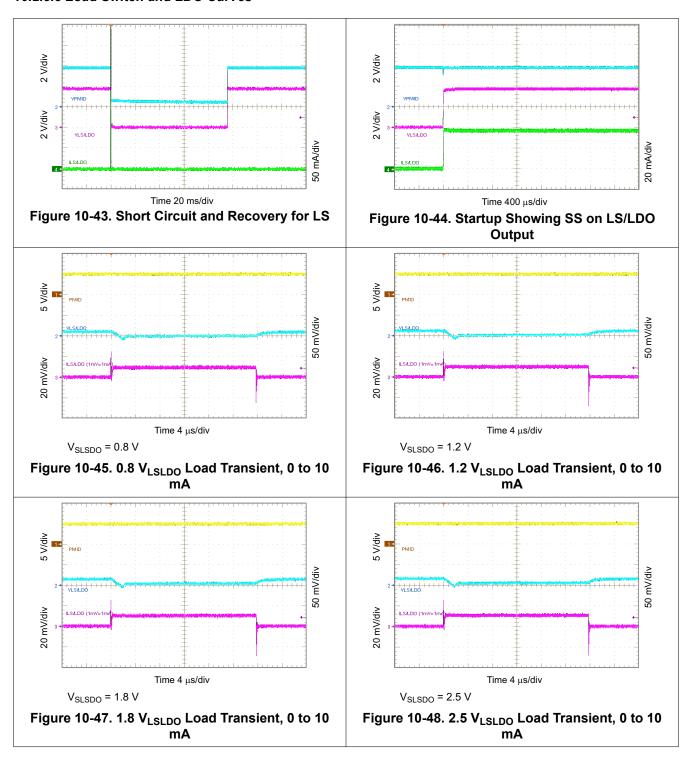




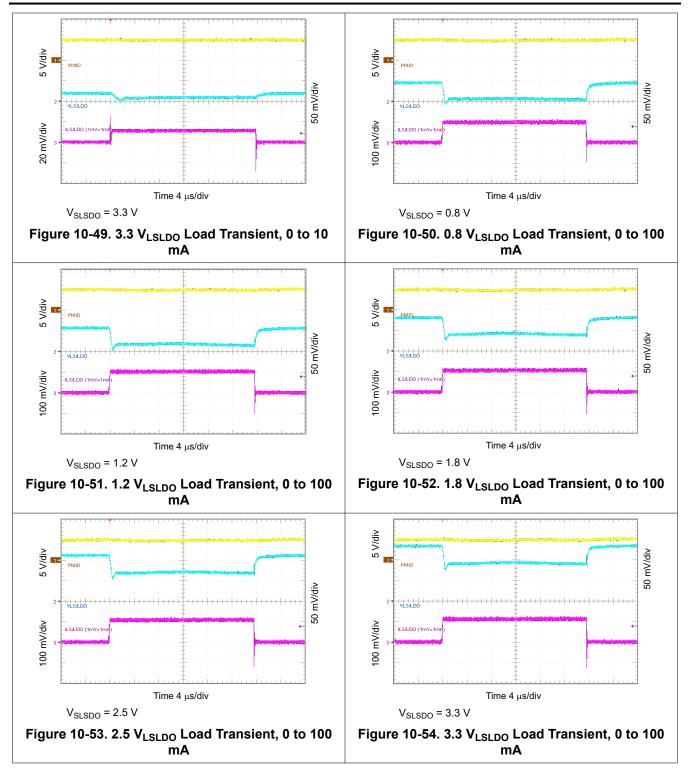




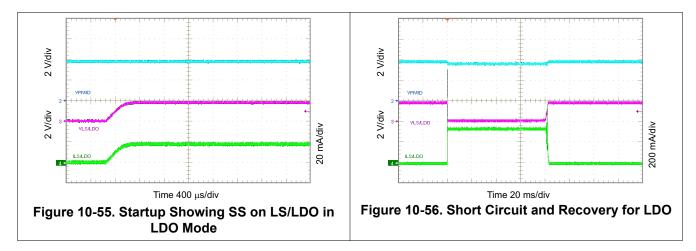
#### 10.2.3.3 Load Switch and LDO Curves





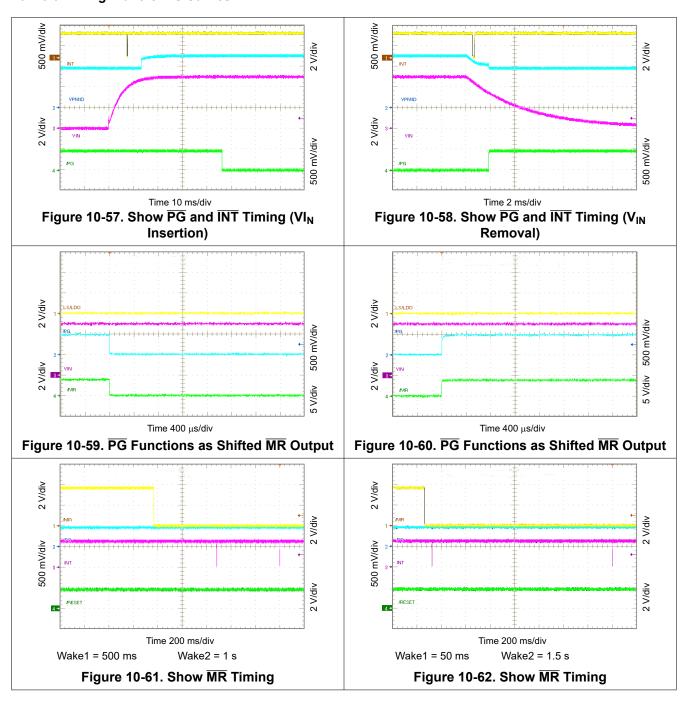


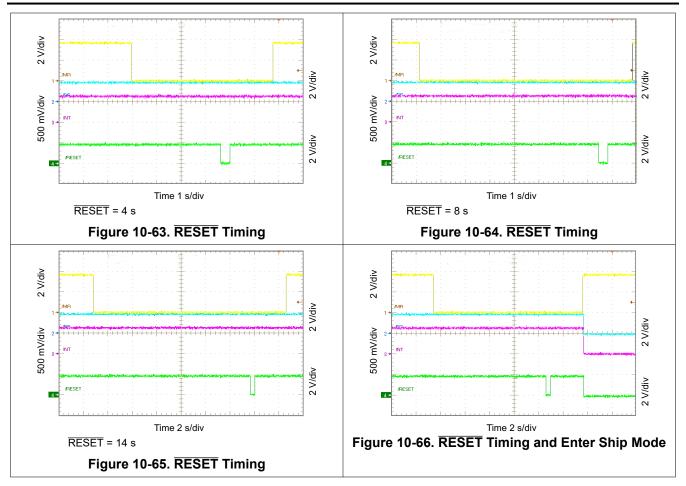
## 10.2.3.4 LS/LDO Output Curves





# 10.2.3.5 Timing Waveforms Curves





# 11 Power Supply Recommendations

It is recommended to use a power supply that is capable of delivering 5 V at the input current limit set by the BQ25125.



## 12 Layout

## 12.1 Layout Guidelines

- · Keep the core components of the system close to each other and the device.
- Keep the PMID, IN, and SYS caps as close to their respective pins as possible. Place the bypass caps for PMID, SYS, and LSLDO close to the pins.
- Place the GNDs of the PMID and IN caps close to each other.
- Don't route so the power planes are interrupted.

### 12.2 Layout Example

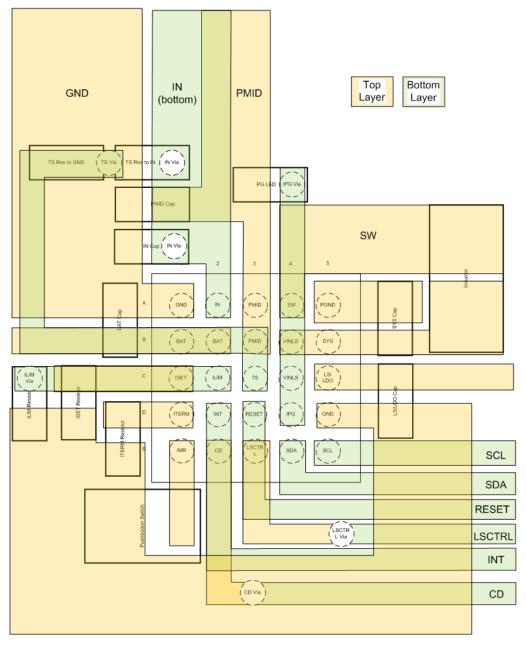


Figure 12-1. BQ25125 Layout

## 13 Device and Documentation Support

### 13.1 Device Support

### 13.1.1 Third-Party Products Disclaimer

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#### 13.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 13.3 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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#### 13.4 Trademarks

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#### 13.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 13.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

### 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 9-Nov-2025

#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow	Peak reflow	
						(4)	(5)		
BQ25125YFPR	Active	Production	DSBGA (YFP)   25	3000   LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ25125
BQ25125YFPR.A	Active	Production	DSBGA (YFP)   25	3000   LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ25125
BQ25125YFPR.B	Active	Production	DSBGA (YFP)   25	3000   LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ25125
BQ25125YFPT	Active	Production	DSBGA (YFP)   25	250   SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ25125
BQ25125YFPT.A	Active	Production	DSBGA (YFP)   25	250   SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ25125
BQ25125YFPT.B	Active	Production	DSBGA (YFP)   25	250   SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ25125

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



# **PACKAGE OPTION ADDENDUM**

www.ti.com 9-Nov-2025

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 9-Jan-2023

### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ25125YFPR	DSBGA	YFP	25	3000	180.0	8.4	2.65	2.65	0.69	4.0	8.0	Q1
BQ25125YFPT	DSBGA	YFP	25	250	180.0	8.4	2.65	2.65	0.69	4.0	8.0	Q1

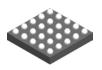
**PACKAGE MATERIALS INFORMATION** 

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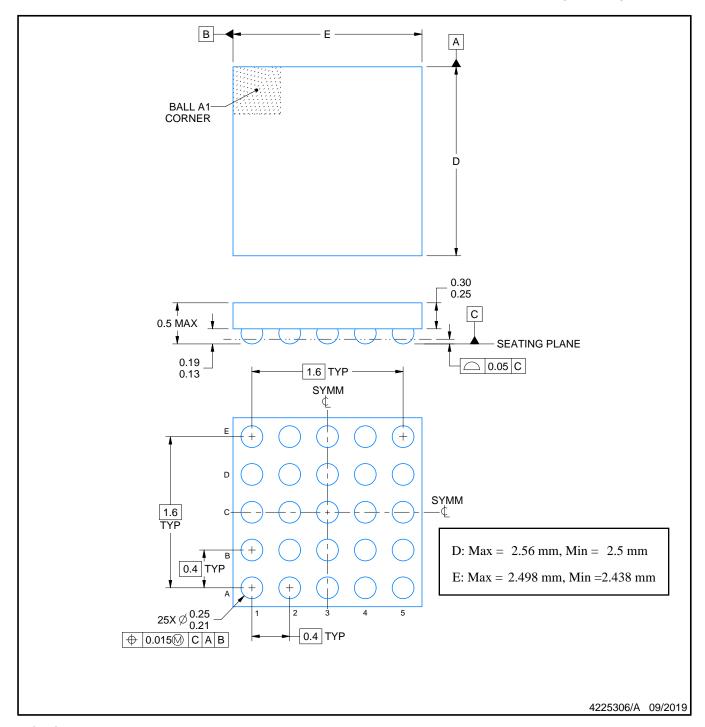


#### \*All dimensions are nominal

	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ı	BQ25125YFPR	DSBGA	YFP	25	3000	182.0	182.0	20.0
ı	BQ25125YFPT	DSBGA	YFP	25	250	182.0	182.0	20.0



DIE SIZE BALL GRID ARRAY



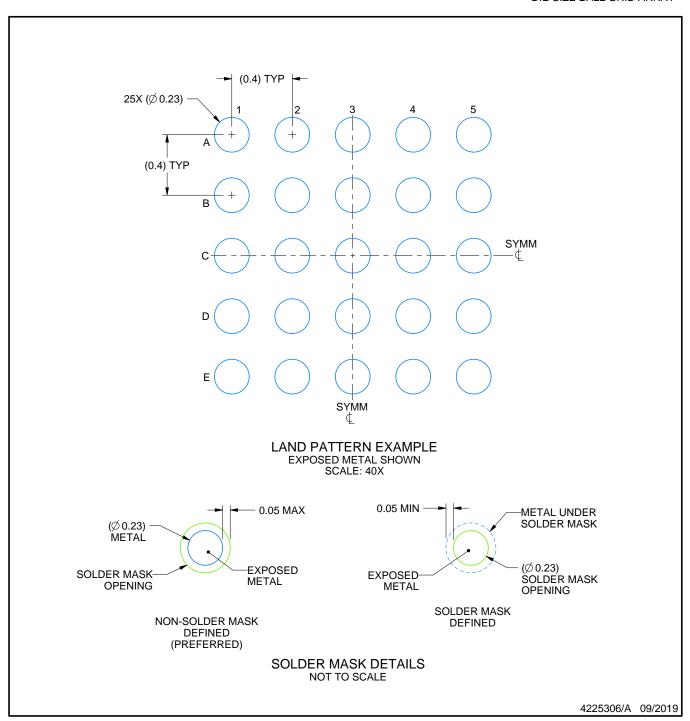
### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.



DIE SIZE BALL GRID ARRAY

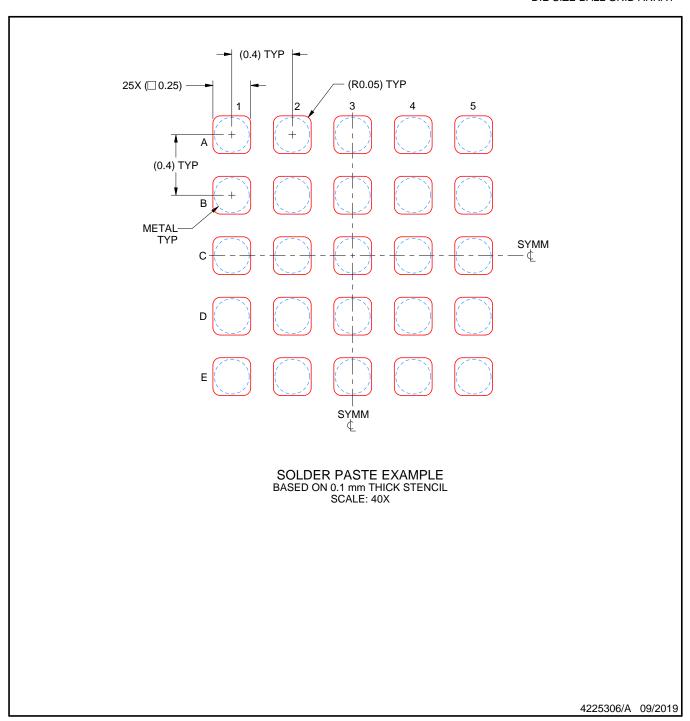


NOTES: (continued)

Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. See Texas Instruments Literature No. SNVA009 (www.ti.com/lit/snva009).



DIE SIZE BALL GRID ARRAY



#### NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



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